

FCC TEST REPORT
for
Anker Technology Co., Limited

Bluetooth Selfie Stick
Model No.: A7134

Prepared for : Anker Technology Co., Limited
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Report Number : R011505906I
Date of Test : Jun. 01~ Jul. 22, 2015
Date of Report : Jul. 23, 2015

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TEST REPORT

Applicant : Anker Technology Co., Limited
Manufacturer : Anker Technology Co., Limited
EUT : Bluetooth Selfie Stick
Model No. : A7134
Serial No. : N.A.
Trade Mark : ANKER
Rating : DC 5V, 1000mA

Measurement Procedure Used:

FCC Part15 Subpart C 2014, Paragraph 15.207, 15.247 & 15.209

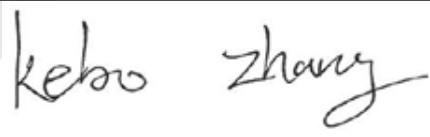
The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the FCC Part 15 Subpart C requirements.

This report applies to above tested sample only and shall not be reproduced in part without

written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Test : Jun. 01~ Jul. 22, 2015

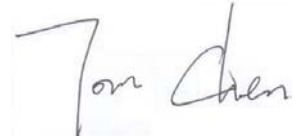
Prepared by :


(Tested Engineer / Kebo Zhang)

Reviewer :


(Project Manager / Amy Ding)

Approved & Authorized Signer :


(Manager / Tom Chen)

1. GENERAL INFORMATION

1.1 Description of Device (EUT)

EUT	: Bluetooth Selfie Stick
Model Number	: A7134
Test Power Supply	: AC 120V, 60Hz for adapter/ AC 240V, 60Hz for adapter/ DC 3.7V Battery inside
Frequency	: 2402~2480MHz
Antenna Specification	: PCB Antenna: -0.58dBi
Modulation	: GFSK, $\pi/4$ DQPSK, 8DPSK
Applicant Address	: Anker Technology Co., Limited Room 1318-19, Hollywood Commercial Center, 610 Nathan Road, Mongkok, Kowloon, Hongkong
Manufacturer Address	: Anker Technology Co., Limited Room 1318-19, Hollywood Commercial Center, 610 Nathan Road, Mongkok, Kowloon, Hongkong
Factory Address	: WINNER'S SUN PLASTIC & ELECTRONIC (SHENZHEN) CO., LTD. 1-4F Block E, 1F, 3F Block D, Area E, Yingtai Industrial Zone, South Dalang Road, Dalang Street, Bao'an District, Shenzhen City, Guangdong Province, People's Republic of China
Date of receipt	: Jun. 01, 2015
Date of Test	: Jun. 01~ Jul. 22, 2015

1.2 Auxiliary Equipment Used during Test

Adapter	: Manufacturer: Samsung M/N: ETA-U90CBC S/N: RT6FB17ZS/B-E Input: AC 100-240V, 50-60Hz, 0.35A Output: DC 5V, 2A
Mobile Phone	: Manufacturer: HUAWEI M/N: C8650 S/N: L6W7NA11B1013157 CE , FCC, DOC

1.3 Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

CNAS - LAB Code: L3503

Shenzhen Anbotek Compliance Laboratory Limited., Laboratory has been assessed and in compliance with CNAS/CL01: 2006 accreditation criteria for testing laboratories (identical to ISO/IEC 17025:2005 General Requirements) for the Competence of Testing Laboratories.

FCC-Registration No.: 752021

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 752021, July 10, 2013.

IC-Registration No.: 8058A-1

Shenzhen Anbotek Compliance Laboratory Limited., EMC Laboratory has been registered and fully described in a report filed with the (IC) Industry Canada. The acceptance letter from the IC is maintained in our files. Registration 8058A, February 22, 2013.

Test Location

All Emissions tests were performed at
Shenzhen Anbotek Compliance Laboratory Limited. at 1/F., Building 1, SEC Industrial Park, No.0409 Qianhai Road, Nanshan District, Shenzhen, Guangdong, China

1.4 Measurement Uncertainty

Radiation Uncertainty	:	Ur = 4.1 dB (Horizontal) Ur = 4.3 dB (Vertical)
Conduction Uncertainty	:	Uc = 3.4dB

2. Test Procedure

GENERAL: This report shall NOT be reproduced except in full without the written approval of Shenzhen Anbotek Compliance Laboratory Limited. The EUT was transmitting a test signal during the testing.

RADIATION INTERFERENCE: The test procedure used was ANSI STANDARD C63.10-2013 using a spectrum analyzer with a pre-selector. The analyzer was calibrated in dB above a microvolt at the output of the antenna. The resolution bandwidth was 100KHz and the video bandwidth was 300KHz up to 1.0GHz and 1.0MHz with a video BW of 3.0MHz above 1.0GHz. The ambient temperature of the EUT was 74.3oF with a humidity of 69%.

FORMULA OF CONVERSION FACTORS: The Field Strength at 3m was established by adding the meter reading of the spectrum analyzer (which is set to read in units of dBuV) to the antenna correction factor supplied by the antenna manufacturer. The antenna correction factors are stated in terms of dB. The gain of the Preselector was accounted for in the Spectrum Analyzer Meter Reading.

Example:

Freq (MHz) METER READING + ACF = FS
20 dBuV + 10.36 dB = 30.36 dBuV/m @ 3m

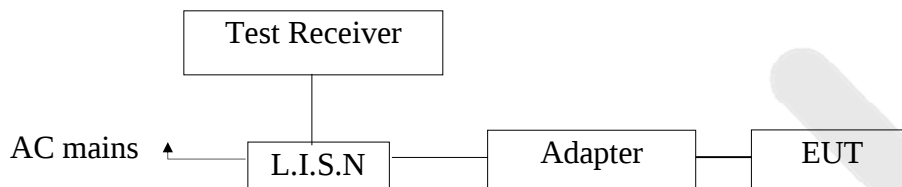
ANSI STANDARD C63.10-2013 10.1.7 MEASUREMENT PROCEDURES: The EUT was placed on a table 80 cm high and with dimensions of 1m by 1.5m. The EUT was placed in the center of the table (1.5m side). The table used for radiated measurements is capable of continuous rotation.

When an emission was found, the table was rotated to produce the maximum signal strength. At this point, the antenna was raised and lowered from 1m to 4m. The antenna was placed in both the horizontal and vertical planes.

3. Conducted Emission

3.1 Block Diagram of Test Setup

3.1.1. Block diagram of connection between the EUT and simulators



3.2 Power Line Conducted Emission Measurement Limits (15.207)

Frequency MHz	Limits dB(μV)	
	Quasi-peak Level	Average Level
0.15 ~ 0.50	66 ~ 56*	56 ~ 46*
0.50 ~ 5.00	56	46
5.00 ~ 30.00	60	50

Notes: 1. *Decreasing linearly with logarithm of frequency.

2. The lower limit shall apply at the transition frequencies.

3.3 Configuration of EUT on Measurement

The following equipments are installed on Power Line Conducted Emission Measurement to meet the commission requirement and operating regulations in a manner which tends to maximize its emission characteristics in a normal application.

3.4 Operating Condition of EUT

3.4.1. Setup the EUT and simulator as shown as Section 3.1.

3.4.2. Turn on the power of all equipment.

3.4.3. Let the EUT work in test mode (Charging) and measure it.

3.5 Test Procedure

The EUT system is connected to the power mains through a line impedance stabilization network (L.I.S.N.). This provides a 50ohm coupling impedance for the EUT system. Please refer the block diagram of the test setup and photographs. Both sides of AC line are checked to find out the maximum conducted emission. In order to find the maximum emission levels, the relative positions of equipment and all of the interface cables shall be changed according to FCC ANSI C63.10-2013 on Conducted Emission Measurement.

The bandwidth of test receiver (ESCI) set at 9KHz.

The frequency range from 150KHz to 30MHz is checked.

The test results are reported on Section 3.6.

Test Equipment

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Two-Line V-network	Rohde & Schwarz	ENV216	100055	Apr. 17, 2015	1 Year
2.	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Apr. 17, 2015	1 Year
3.	RF Switching Unit	Compliance Direction	RSU-M2	38303	Apr. 17, 2015	1 Year

3.6 Power Line Conducted Emission Measurement Results

PASS.

The frequency range from 150KHz to 30 MHz is investigated.

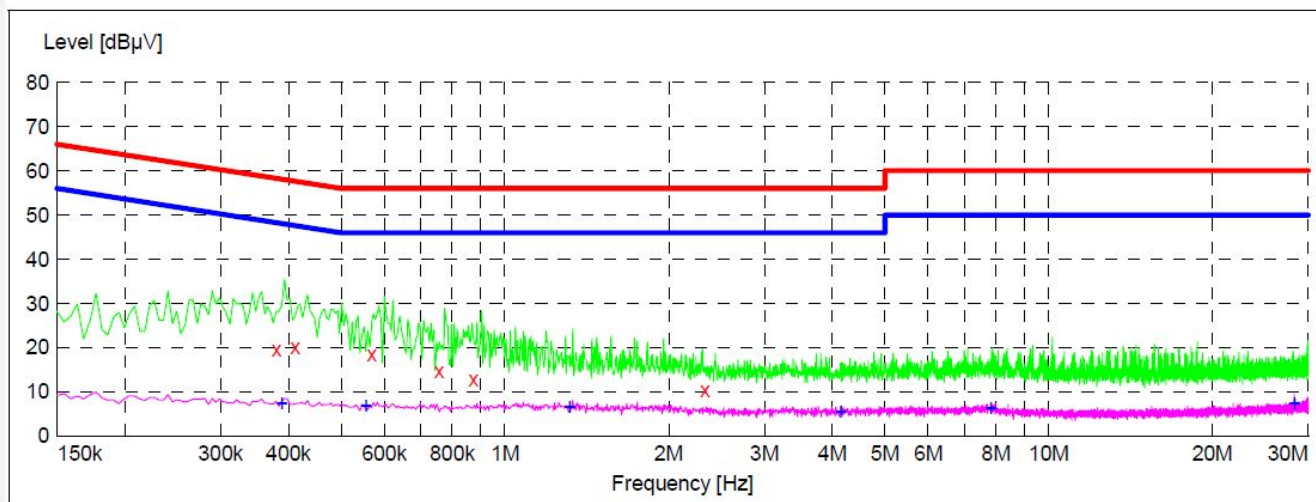
Please refer the following pages.

CONDUCTED EMISSION TEST DATA

Test Site: 1# Shielded Room
Operating Condition: Charging
Test Specification: AC 120V, 60Hz for adapter
Comment: Live Line
Tem.:25°C Hum.:50%

SCAN TABLE: "Voltage (150K~30M) FIN"

Short Description: 150K-30M Disturbance Voltages



Frequency MHz	Level dBμV	Transd dB	Limit dBμV	Margin dB	Detector	Line	PE
0.379500	19.70	20.1	58	38.6	QP	L1	GND
0.411000	20.20	20.1	58	37.4	QP	L1	GND
0.568500	18.60	20.1	56	37.4	QP	L1	GND
0.757500	14.80	20.1	56	41.2	QP	L1	GND
0.874500	12.90	20.1	56	43.1	QP	L1	GND
2.332000	10.50	20.3	56	45.5	QP	L1	GND

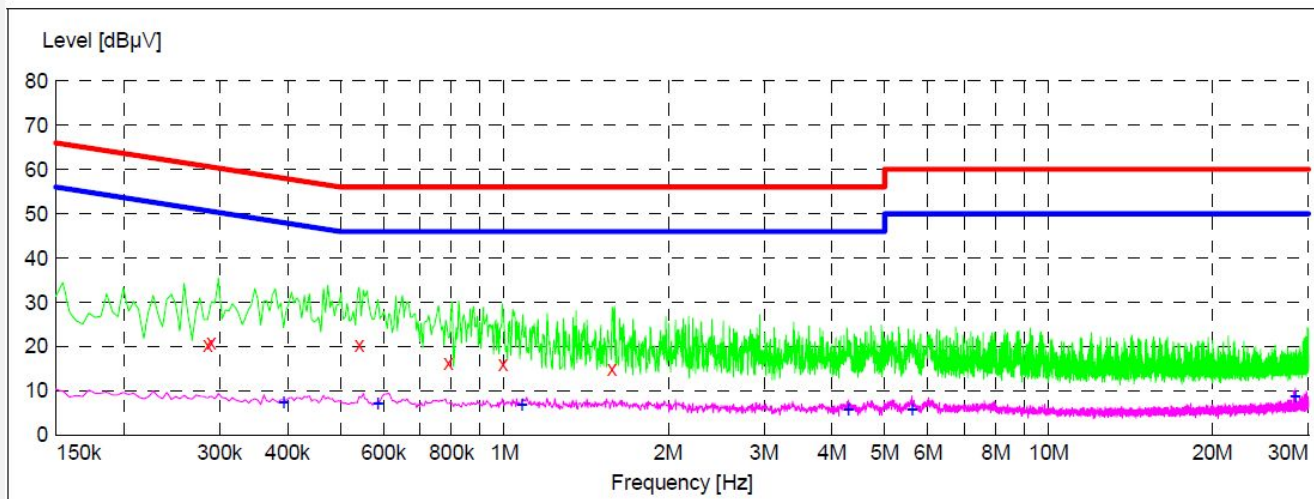
Frequency MHz	Level dBμV	Transd dB	Limit dBμV	Margin dB	Detector	Line	PE
0.388500	7.30	20.1	48	40.8	AV	L1	GND
0.555000	7.00	20.1	46	39.0	AV	L1	GND
1.315000	6.60	20.2	46	39.4	AV	L1	GND
4.136500	5.50	20.5	46	40.5	AV	L1	GND
7.826500	6.30	20.5	50	43.7	AV	L1	GND
28.283500	7.30	20.9	50	42.7	AV	L1	GND

CONDUCTED EMISSION TEST DATA

Test Site: 1# Shielded Room
Operating Condition: Charging
Test Specification: AC 120V, 60Hz for adapter
Comment: Neutral Line
Tem.:25°C Hum.:50%

SCAN TABLE: "Voltage (150K~30M) FIN"

Short Description: 150K-30M Disturbance Voltages



Frequency MHz	Level dBμV	Transd dB	Limit dBμV	Margin dB	Detector	Line	PE
0.285000	20.30	20.1	61	40.4	QP	N	GND
0.289500	21.00	20.1	61	39.5	QP	N	GND
0.541500	20.50	20.1	56	35.5	QP	N	GND
0.789000	16.50	20.1	56	39.5	QP	N	GND
0.996000	16.00	20.2	56	40.0	QP	N	GND
1.576000	15.10	20.3	56	40.9	QP	N	GND

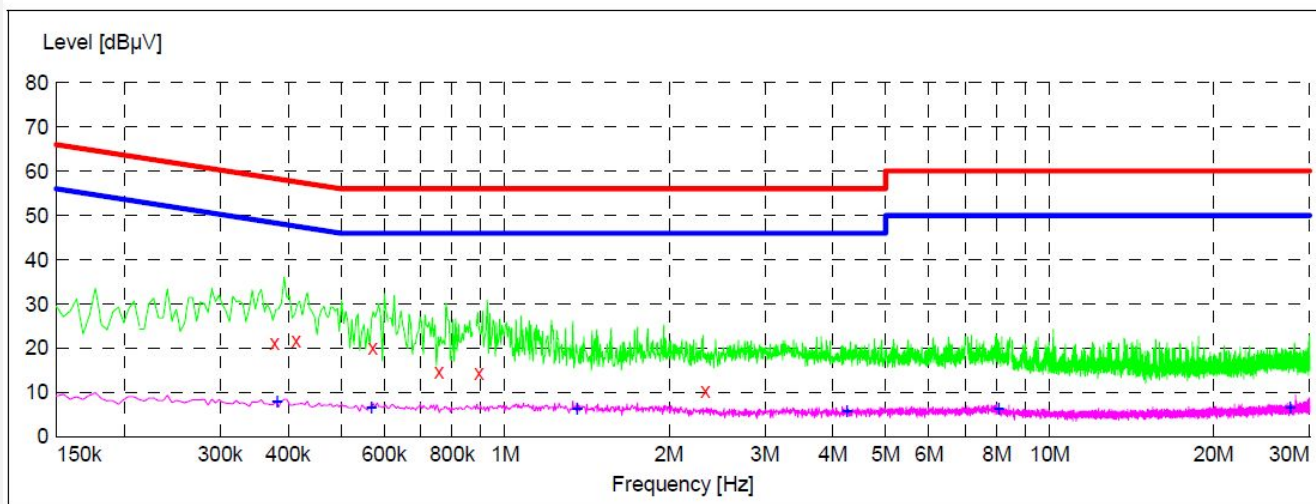
Frequency MHz	Level dBμV	Transd dB	Limit dBμV	Margin dB	Detector	Line	PE
0.393000	7.50	20.1	48	40.5	AV	N	GND
0.586500	7.10	20.1	46	38.9	AV	N	GND
1.076500	6.90	20.2	46	39.1	AV	N	GND
4.289500	5.70	20.5	46	40.3	AV	N	GND
5.612500	5.90	20.5	50	44.1	AV	N	GND
28.409500	8.90	20.9	50	41.1	AV	N	GND

CONDUCTED EMISSION TEST DATA

Test Site: 1# Shielded Room
Operating Condition: Charging
Test Specification: AC 240V, 60Hz for adapter
Comment: Live Line
Tem.:25°C Hum.:50%

SCAN TABLE: "Voltage (150K~30M) FIN"

Short Description: 150K-30M Disturbance Voltages



Frequency MHz	Level dBμV	Transd dB	Limit dBμV	Margin dB	Detector	Line	PE
0.354500	20.20	20.1	58	37.8	QP	L1	GND
0.424200	21.40	20.1	58	36.6	QP	L1	GND
0.536100	19.50	20.1	56	36.5	QP	L1	GND
0.712300	13.70	20.1	56	42.3	QP	L1	GND
0.845600	12.60	20.1	56	43.4	QP	L1	GND
2.752000	10.60	20.3	56	45.4	QP	L1	GND

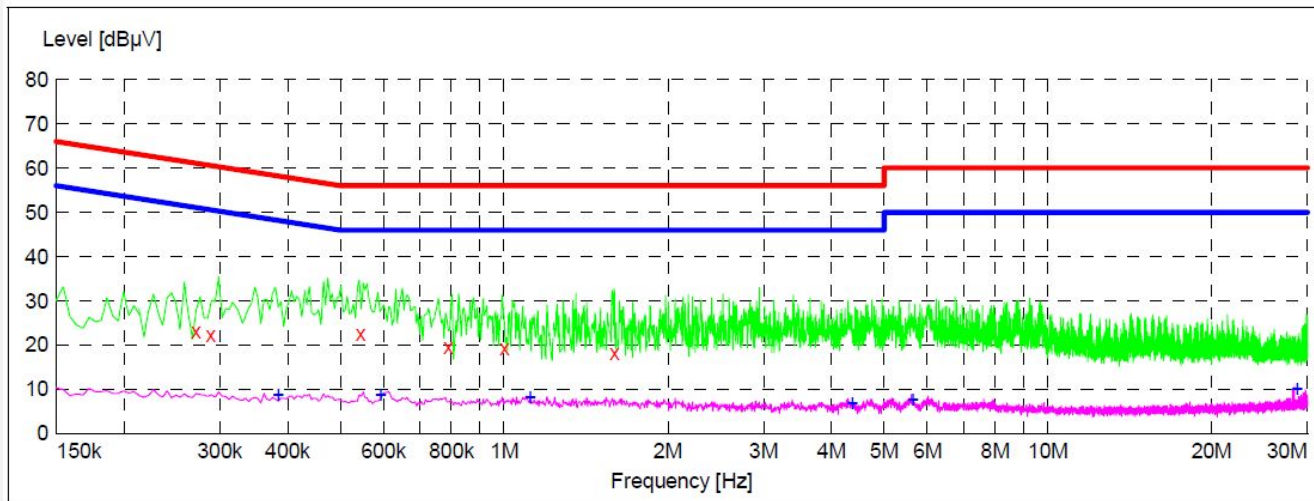
Frequency MHz	Level dBμV	Transd dB	Limit dBμV	Margin dB	Detector	Line	PE
0.363200	7.40	20.1	48	40.6	AV	L1	GND
0.542000	6.80	20.1	46	39.2	AV	L1	GND
1.234000	6.90	20.2	46	39.1	AV	L1	GND
4.236500	5.30	20.5	46	40.7	AV	L1	GND
7.765200	6.70	20.5	50	43.3	AV	L1	GND
28.495200	6.90	20.9	50	42.1	AV	L1	GND

CONDUCTED EMISSION TEST DATA

Test Site: 1# Shielded Room
Operating Condition: Charging
Test Specification: AC 240V, 60Hz for adapter
Comment: Neutral Line
Tem.:25°C Hum.:50%

SCAN TABLE: "Voltage (150K~30M) FIN"

Short Description: 150K-30M Disturbance Voltages



Frequency MHz	Level dBμV	Transd dB	Limit dBμV	Margin dB	Detector	Line	PE
0.275000	22.20	20.1	61	38.8	QP	N	GND
0.256800	21.50	20.1	61	39.5	QP	N	GND
0.535200	21.90	20.1	56	34.1	QP	N	GND
0.756000	18.50	20.1	56	37.5	QP	N	GND
0.975000	18.70	20.2	56	37.3	QP	N	GND
1.468000	17.10	20.3	56	38.9	QP	N	GND

Frequency MHz	Level dBμV	Transd dB	Limit dBμV	Margin dB	Detector	Line	PE
0.386000	8.30	20.1	48	39.7	AV	N	GND
0.554600	8.20	20.1	46	37.8	AV	N	GND
1.156800	7.90	20.2	46	38.1	AV	N	GND
4.285400	6.70	20.5	46	39.3	AV	N	GND
5.563200	6.90	20.5	50	43.1	AV	N	GND
28.389650	10.20	20.9	50	39.8	AV	N	GND

4. Radiation Interference

4.1 Requirements (15.247, 15.209):

4.1.1. Test Limits (< 30 MHz)

Frequency (MHz)	Field Strength (microvolts/meter)	Measurement Distance (meter)
0.009-0.490	2400/F(kHz)	300
0.490-1.705	24000/F(kHz)	30
1.705-30.0	30	30

4.1.2. Test Limits ($\geq$ 30 MHz)

FIELD STRENGTH of Fundamental: @3M	FIELD STRENGTH of Harmonics	S15.209 30 - 88 MHz	40 dBuV/m
902-928 MHz		88 - 216 MHz	43.5
2.4-2.4835 GHz		216 - 960 MHz	46
94 dBuV/m @3m	54 dBuV/m @3m	ABOVE 960 MHz	54dBuV/m

For range 9KHz~30MHz, The measured value is really too low to be recorded.

Emissions radiated outside of the specified frequency bands, except for harmonics, shall be attenuated by at least 50 dB below the level of the fundamental or to the general radiated emission limits in 15.209, whichever is the lesser attenuation.

4.2 Test Procedure

For below 1GHz: The EUT is placed on a turntable, which is 0.8m above the ground plane.
For above 1GHz: The EUT is placed on a turntable, which is 1.5m above the ground plane.
The turn table can rotate 360 degrees to determine the position of the maximum emission level.
The EUT is set 3 meters away from the receiving antenna which is mounted on a antenna tower.
The antenna can be moved up and down from 1 to 4 meters to find out the maximum emission level. Rotated the EUT through three orthogonal axes to determine the maximum emissions, both horizontal and vertical polarization of the antenna are set on test. The EUT is tested in 9*6*6 Chamber. The device is evaluated in xyz orientation.

For 30MHz to 1000MHz:

Set the spectrum analyzer as:
RBW = 100kHz, VBW =300kHz,
Detector= Quasi-Peak
Trace mode= Max hold.
Sweep- auto couple.

For Above 1GHz:

Set the spectrum analyzer as:
RBW = 1MHz, VBW =3MHz,
Detector= Peak

Trace mode= Max hold.
Sweep- auto couple.

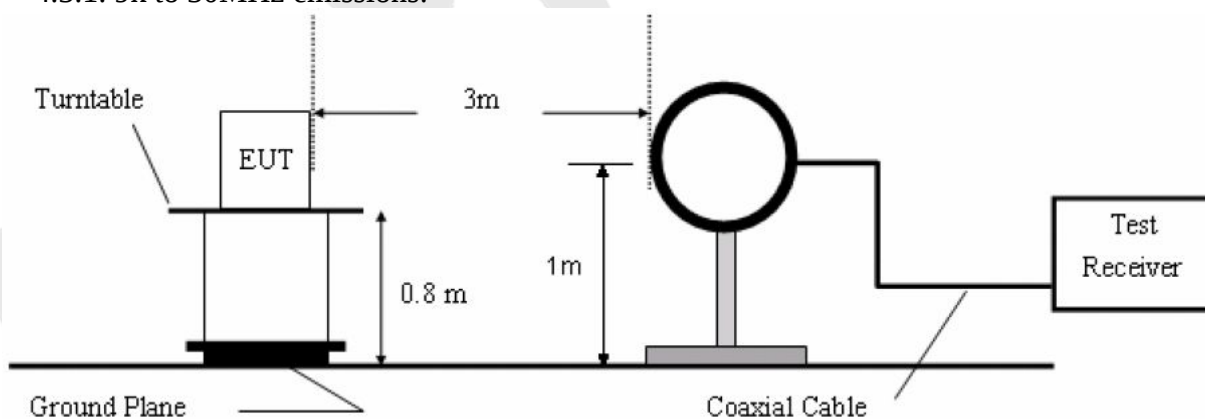
Set the spectrum analyzer as:
RBW =1MHz, VBW =10Hz
Detector= Average
Trace mode= Max hold.
Sweep- auto couple.

Test Equipment

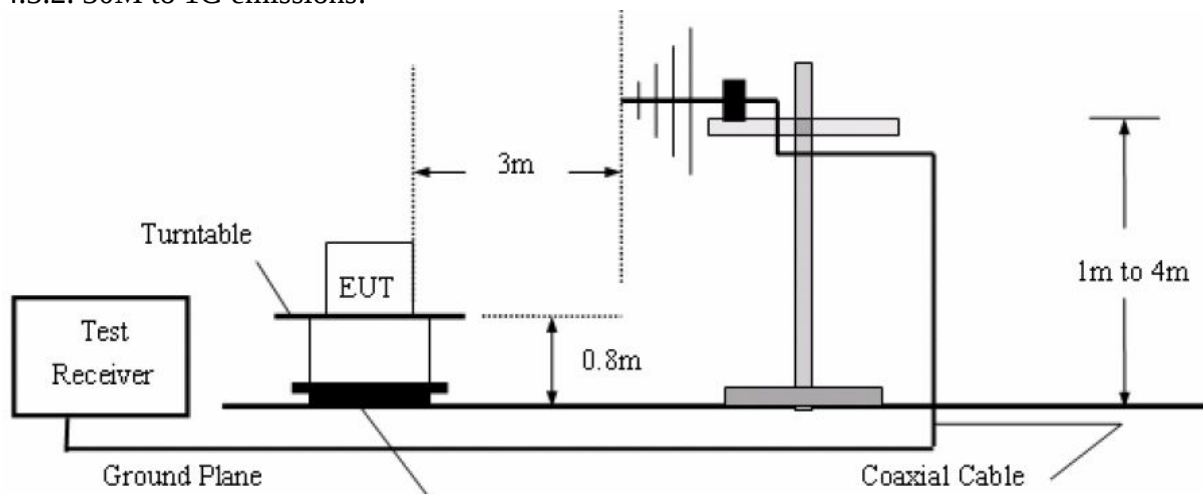
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Spectrum Analysis	Agilent	E4407B	US39390582	Apr. 17, 2015	1 Year
2.	Preamplifier	Instruments corporation	EMC011830	980100	Apr. 17, 2015	1 Year
3.	EMI Test Receiver	Rohde & Schwarz	ESPI	101604	Apr. 17, 2015	1 Year
4.	Double Ridged Horn Antenna	Instruments corporation	GTH-0118	351600	Apr. 20, 2015	1 Year
5.	Bilog Broadband Antenna	Schwarzbeck	VULB9163	VULB 9163-289	Apr. 20, 2015	1 Year
6.	Pre-amplifier	SONOMA	310N	186860	Apr. 17, 2015	1 Year
7.	EMI Test Software EZ-EMC	SHURPLE	N/A	N/A	N/A	N/A

4.3 Test Configuration

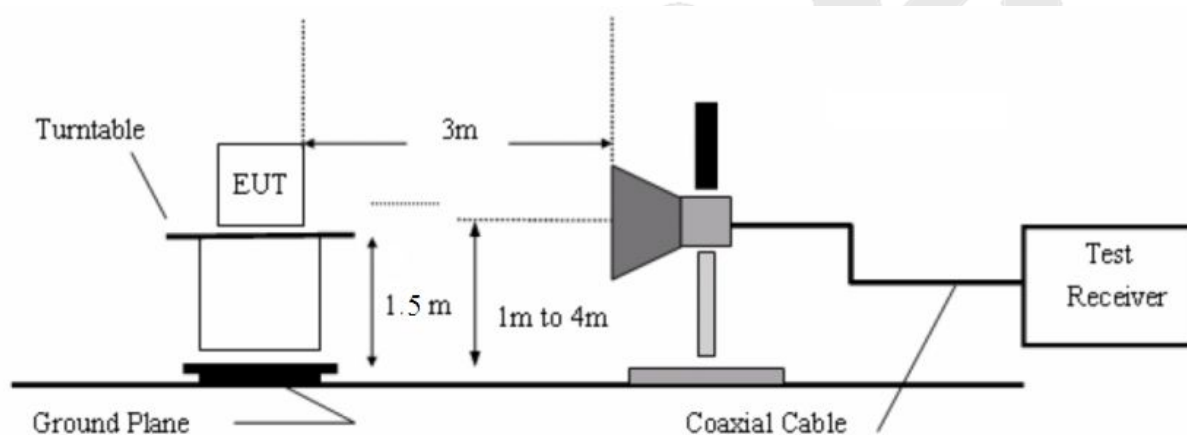
4.3.1. 9k to 30MHz emissions:



4.3.2. 30M to 1G emissions:



4.3.3. 1G to 40G emissions:



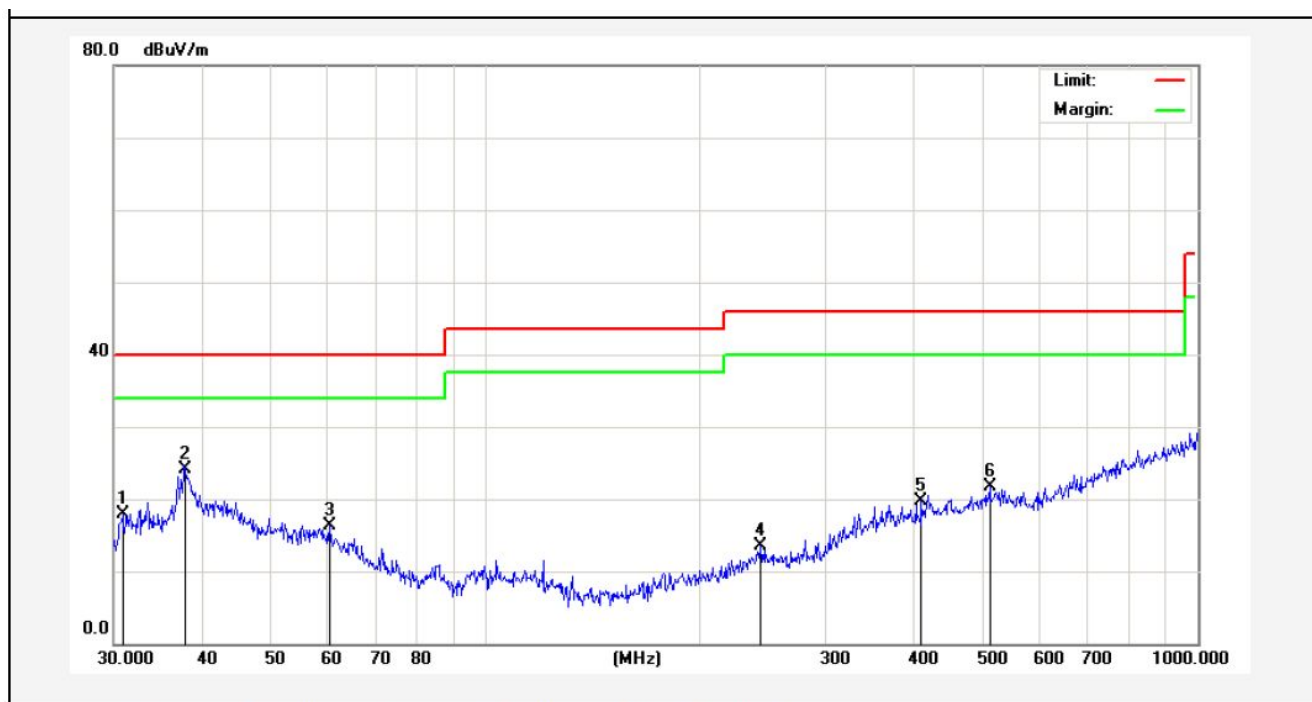
4.4 Test Results

PASS.

The EUT was tested on (Charging, On) modes, only the worst data of (On) are attached in the following pages.

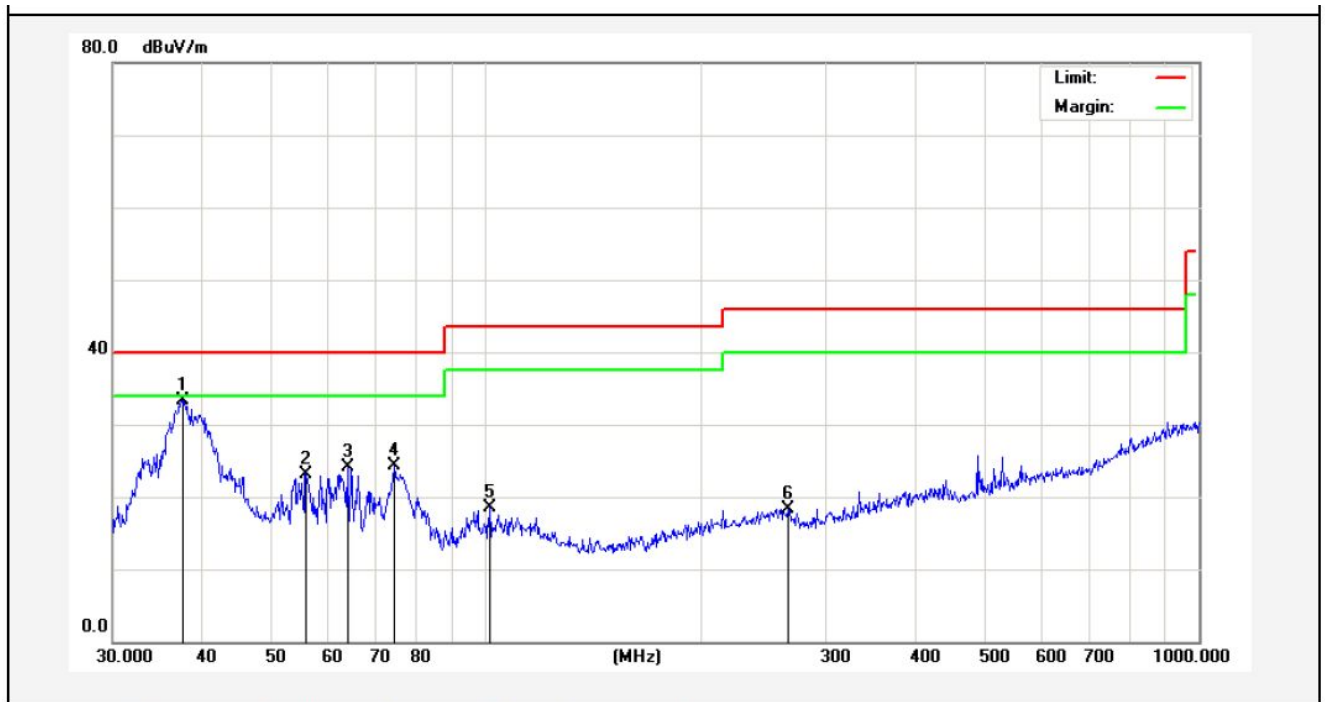
Only the worst case (x orientation).

Job No.:	011505906I	Polarization:	Horizontal
Standard:	(RE)FCC PART 15C _3m	Power Source:	DC 3.7V
Test item:	Radiation Test (30~1000MHz)	Temp.(C)/Hum.(%RH):	24.3(C)/55%RH
Test Mode:	On	Distance:	3m



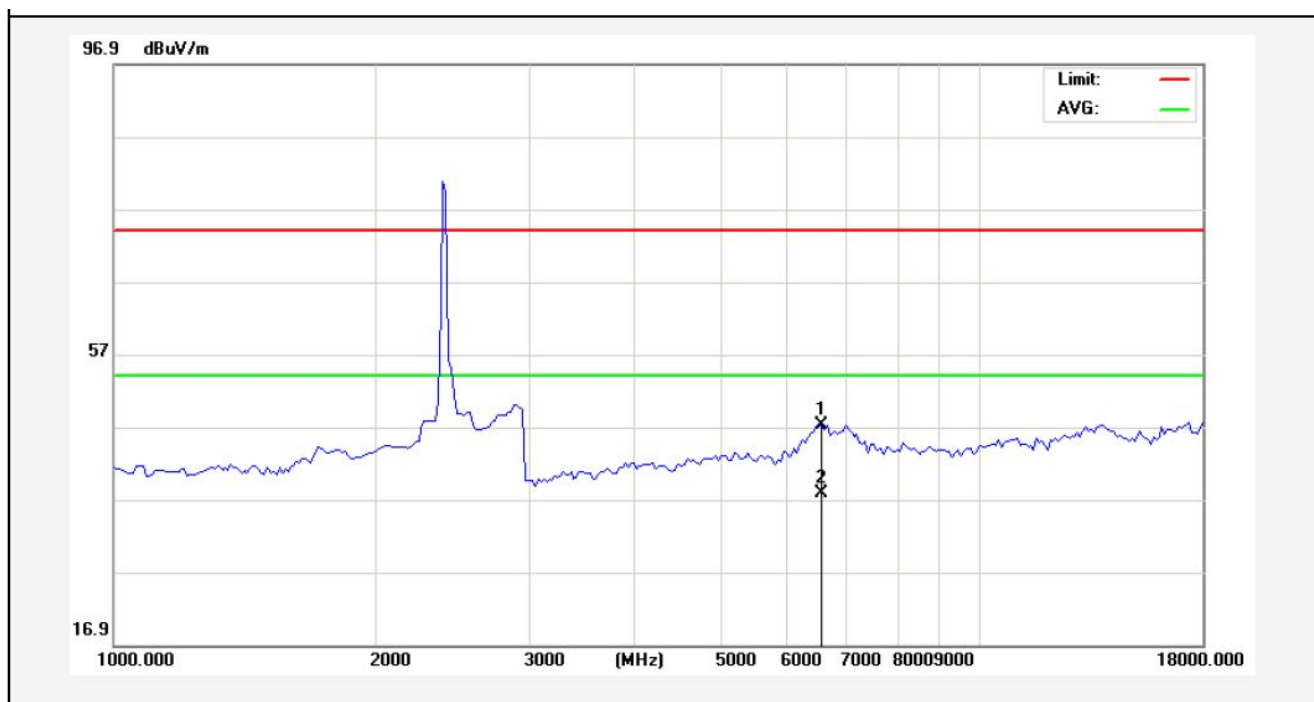
No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	30.8535	34.50	-16.50	18.00	40.00	-22.00	peak			
2	37.8121	36.27	-12.09	24.18	40.00	-15.82	peak			
3	60.2801	31.80	-15.51	16.29	40.00	-23.71	peak			
4	243.3772	31.77	-18.24	13.53	46.00	-32.47	peak			
5	408.9460	32.38	-12.65	19.73	46.00	-26.27	peak			
6	510.0436	32.63	-10.97	21.66	46.00	-24.34	peak			

Job No.:	011505906I	Polarization:	Vertical
Standard:	(RE)FCC PART 15C _3m	Power Source:	DC 3.7V
Test item:	Radiation Test (30~1000MHz)	Temp.(C)/Hum.(%RH):	24.3(C)/55%RH
Test Mode:	On	Distance:	3m



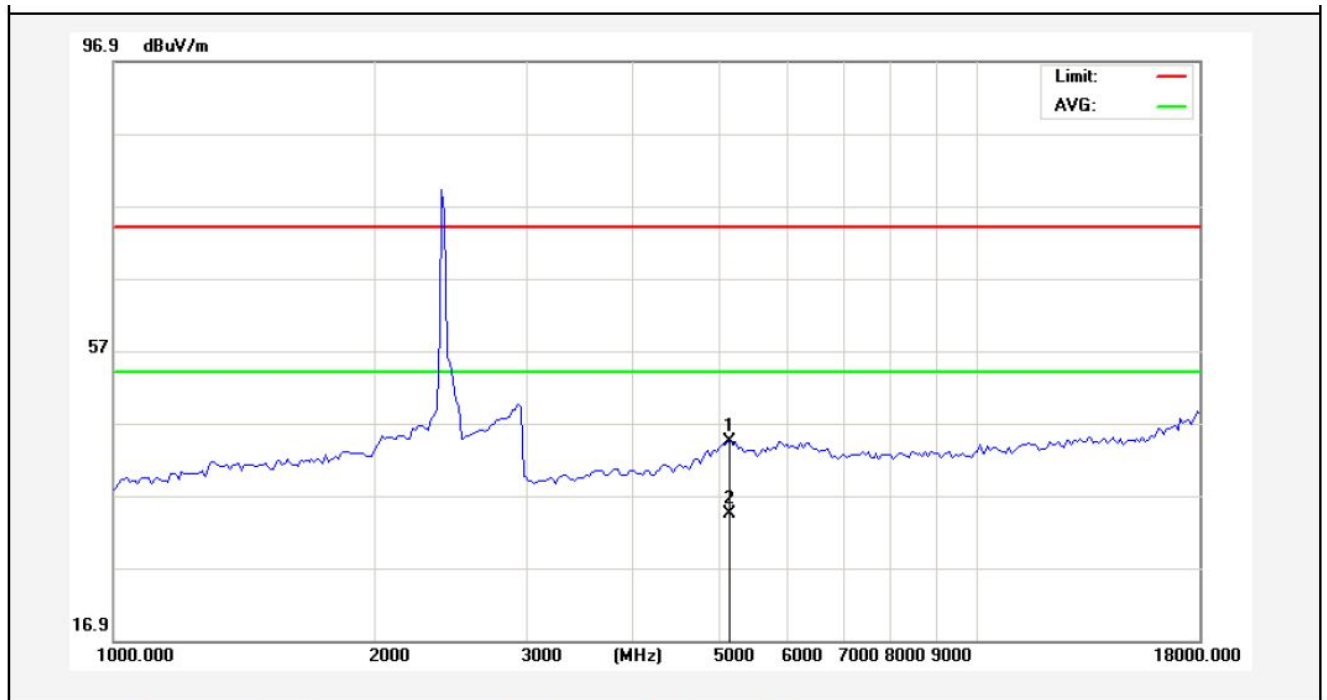
No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	37.6798	45.53	-12.19	33.34	40.00	-6.66	peak			
2	56.0007	38.21	-15.03	23.18	40.00	-16.82	peak			
3	63.9828	41.08	-17.05	24.03	40.00	-15.97	peak			
4	74.3955	44.83	-20.48	24.35	40.00	-15.65	peak			
5	101.2885	34.29	-15.75	18.54	43.50	-24.96	peak			
6	265.6757	32.66	-14.34	18.32	46.00	-27.68	peak			

Job No.:	011505906I	Polarization:	Horizontal
Standard:	(RE)FCC PART 15C_Class B_3m	Power Source:	DC 3.7V
Test item:	Radiation Test (Above 1GHz)	Temp.(C)/Hum.(%RH):	24.3(C)/55%RH
Test Mode:	TX(2402 MHz)	Distance:	3m



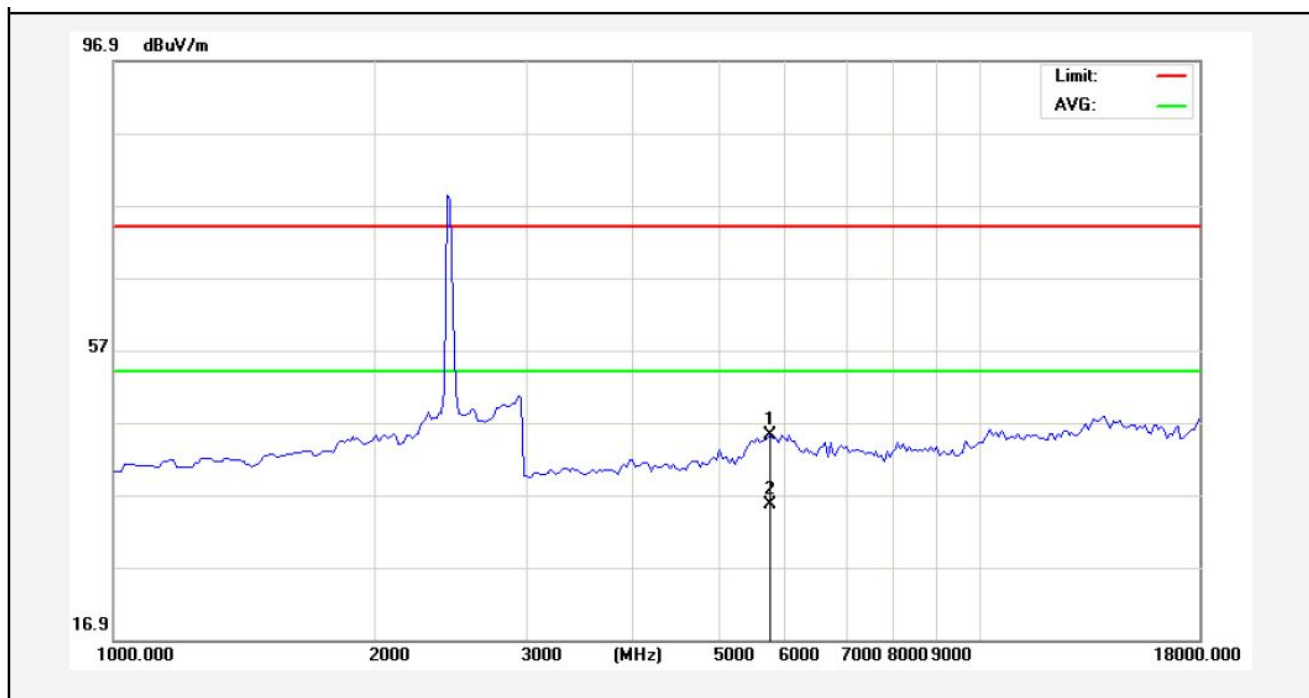
No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	6567.500	39.54	7.68	47.22	74.00	-26.78	peak			
2	6567.500	30.16	7.68	37.84	54.00	-16.16	AVG			

Job No.:	011505906I	Polarization:	Vertical
Standard:	(RE)FCC PART 15C_Class B_3m	Power Source:	DC 3.7V
Test item:	Radiation Test (Above 1GHz)	Temp.(C)/Hum.(%RH):	24.3(C)/55%RH
Test Mode:	TX(2402 MHz)	Distance:	3m



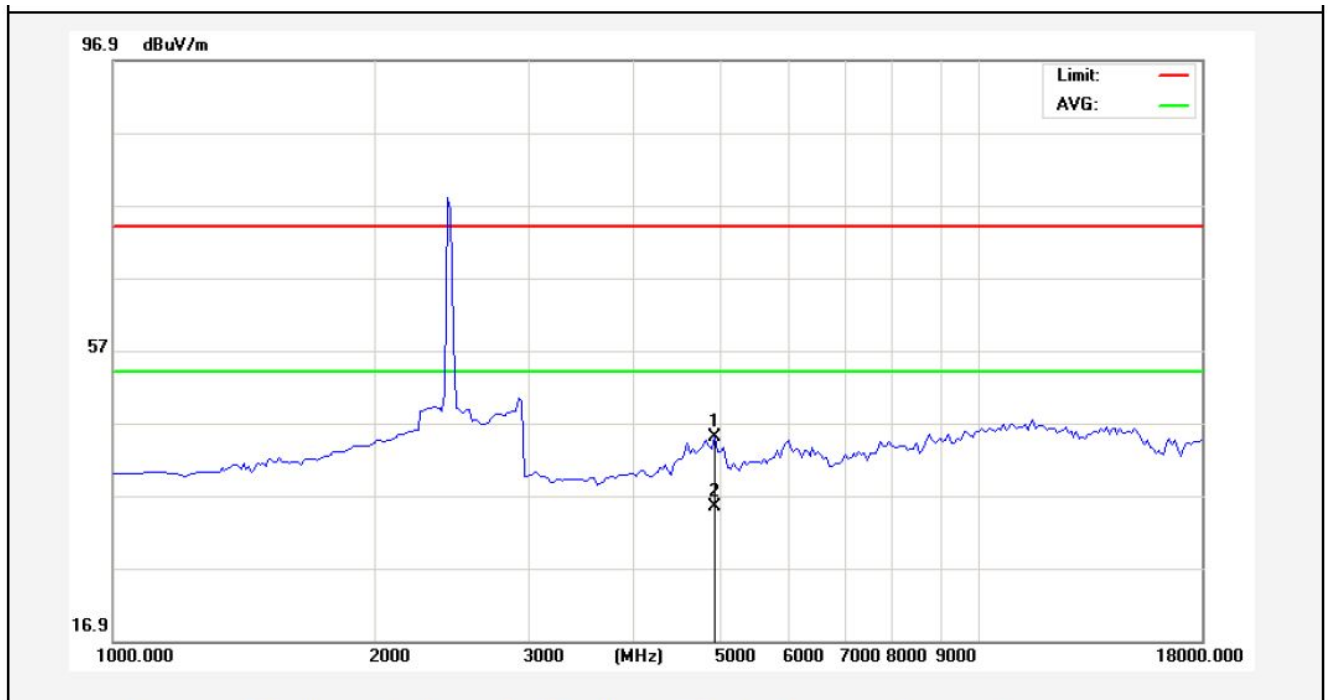
No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	5165.000	40.73	3.76	44.49	74.00	-29.51	peak			
2	5165.000	30.71	3.76	34.47	54.00	-19.53	AVG			

Job No.:	011505906I	Polarization:	Horizontal
Standard:	(RE)FCC PART 15C_Class B_3m	Power Source:	DC 3.7V
Test item:	Radiation Test (Above 1GHz)	Temp.(C)/Hum.(%RH):	24.3(C)/55%RH
Test Mode:	TX(2441 MHz)	Distance:	3m



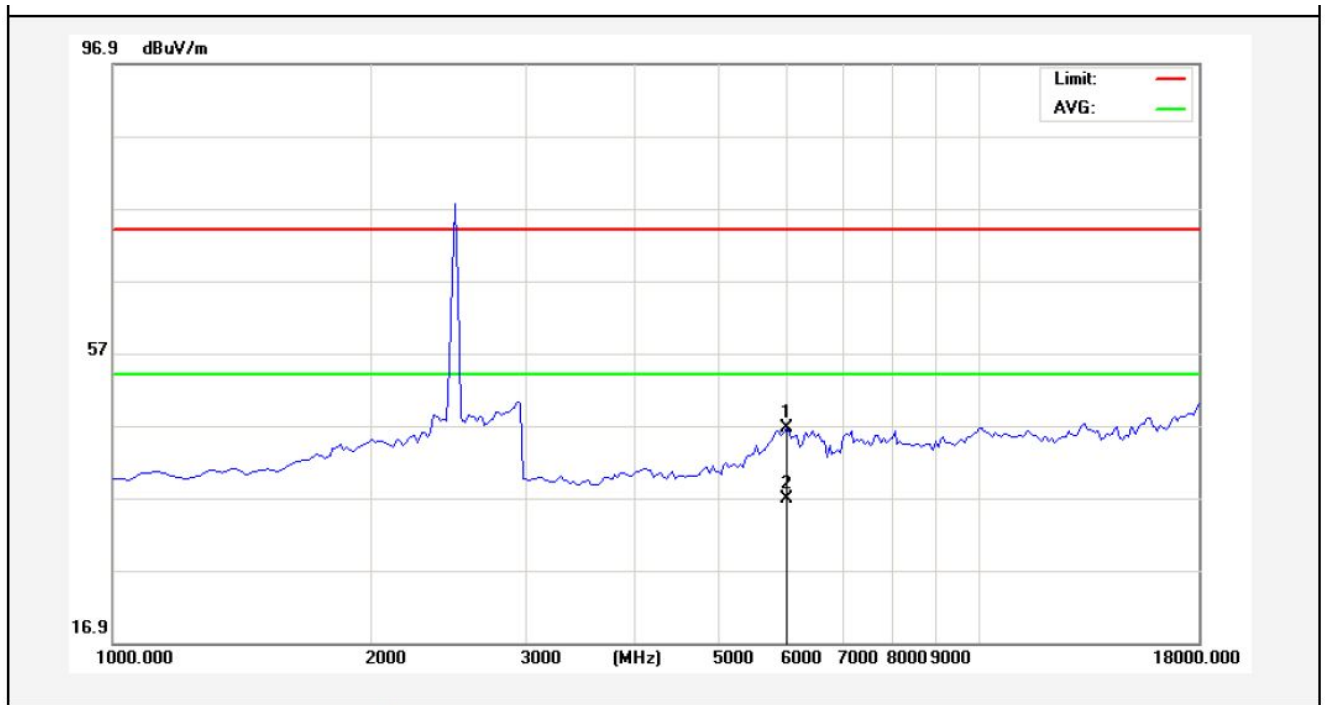
No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	5760.000	39.61	5.63	45.24	74.00	-28.76	peak			
2	5760.000	29.96	5.63	35.59	54.00	-18.41	AVG			

Job No.:	011505906I	Polarization:	Vertical
Standard:	(RE)FCC PART 15C_Class B_3m	Power Source:	DC 3.7V
Test item:	Radiation Test (Above 1GHz)	Temp.(C)/Hum.(%RH):	24.3(C)/55%RH
Test Mode:	TX(2441 MHz)	Distance:	3m



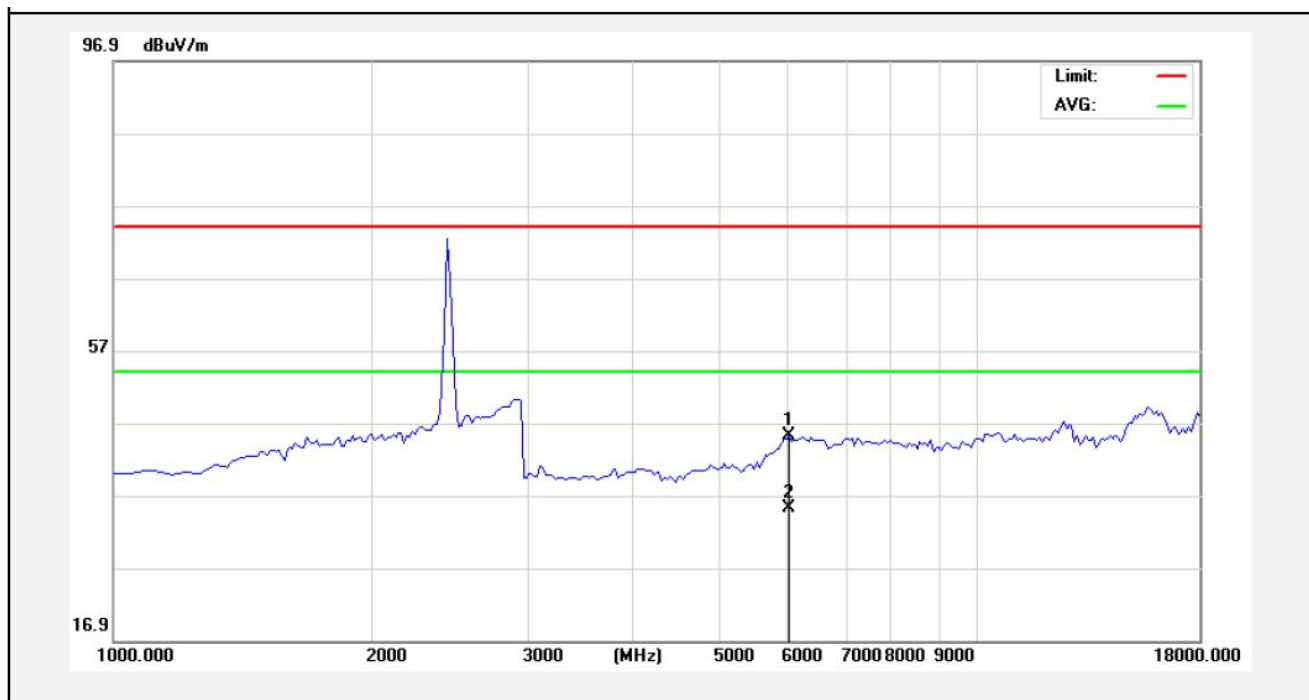
No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	4952.500	41.49	3.57	45.06	74.00	-28.94	peak			
2	4952.500	31.84	3.57	35.41	54.00	-18.59	AVG			

Job No.:	011505906I	Polarization:	Horizontal
Standard:	(RE)FCC PART 15C_Class B_3m	Power Source:	DC 3.7V
Test item:	Radiation Test (Above 1GHz)	Temp.(C)/Hum.(%RH):	24.3(C)/55%RH
Test Mode:	TX(2480 MHz)	Distance:	3m



No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	6015.000	39.44	7.14	46.58	74.00	-27.42	peak			
2	6015.000	29.71	7.14	36.85	54.00	-17.15	AVG			

Job No.:	011505906I	Polarization:	Vertical
Standard:	(RE)FCC PART 15C_Class B_3m	Power Source:	DC 3.7V
Test item:	Radiation Test (Above 1GHz)	Temp.(C)/Hum.(%RH):	24.3(C)/55%RH
Test Mode:	TX(2480 MHz)	Distance:	3m



No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	6057.500	38.00	7.18	45.18	74.00	-28.82	peak			
2	6057.500	28.02	7.18	35.20	54.00	-18.80	AVG			

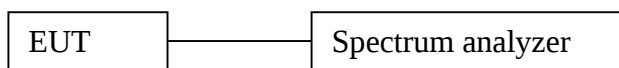
5. CHANNEL SEPARATION TEST

5.1 Measurement Procedure

The EUT must have its hopping function enabled. Using the following spectrum analyzer settings:

1. Span= Wide enough to capture the peaks of two adjacent channels
2. Set the RBW = 30 kHz.
3. Set the VBW = 100 kHz.
4. Sweep time = auto couple.
5. Detector function = peak.
6. Trace mode = max hold.
7. Allow trace to fully stabilize.

5.2 Test SET-UP



5.3 Test Equipment

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Spectrum Analysis	Agilent	E4407B	US39390582	Apr. 17, 2015	1 Year
2.	Preamplifier	Instruments corporation	EMC011830	980100	Apr. 17, 2015	1 Year
3.	EMI Test Receiver	Rohde & Schwarz	ESPI	101604	Apr. 17, 2015	1 Year
4.	Double Ridged Horn Antenna	Instruments corporation	GTH-0118	351600	Apr. 20, 2015	1 Year
5.	Bilog Broadband Antenna	Schwarzbeck	VULB9163	VULB 9163-289	Apr. 20, 2015	1 Year
6.	Pre-amplifier	SONOMA	310N	186860	Apr. 17, 2015	1 Year
7.	EMI Test Software EZ-EMC	SHURPLE	N/A	N/A	N/A	N/A

5.4 Test Results

Test Item : Frequency Separation Test Mode : CH Low ~ CH High
Test Voltage : DC 3.7V Temperature : 24°C
Test Result : PASS Humidity : 55%RH

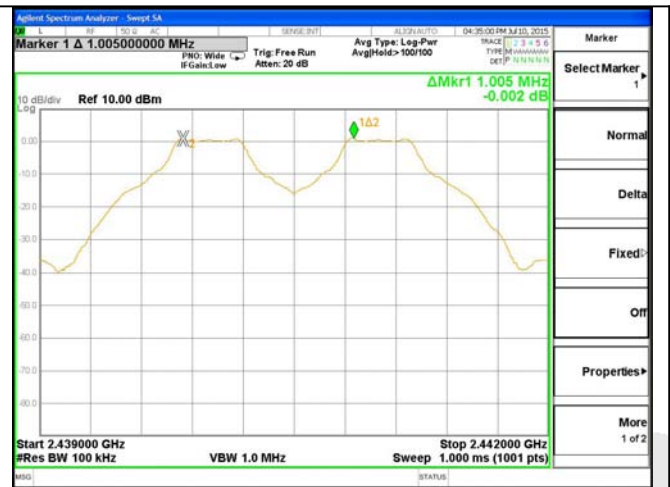
Channel	Frequency (MHz)	Separation Read Value (kHz)	Limit (kHz)	Modulation Mode
Low	2401	1005	927.0	BDR
Mid	2441	1005	930.4	BDR
High	2480	1005	928.3	BDR
Low	2401	1005	843.3	EDR
Mid	2441	1005	844.0	EDR
High	2480	1005	842.0	EDR

Remark:

1. The limit of mode (EDR) is 2/3 of 20dB BW;



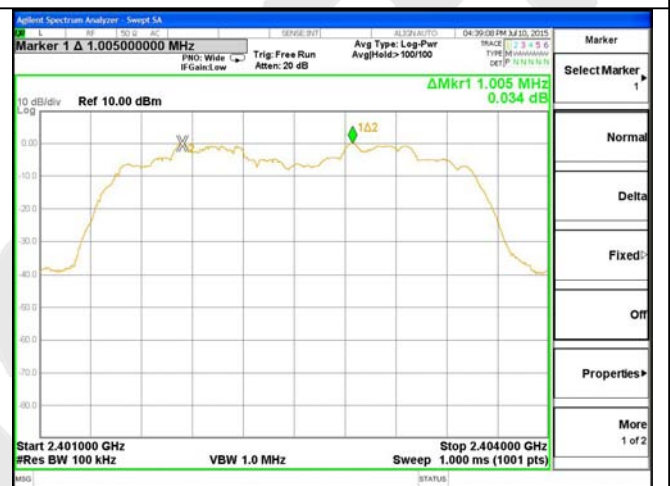
Test Mode: BDR---Low



Test Mode: BDR---Mid



Test Mode: BDR---High



Test Mode: EDR---Low



Test Mode: EDR---Mid



Test Mode: EDR---High

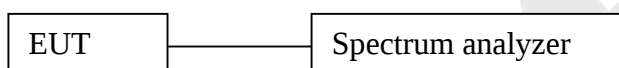
6. 20DB BANDWIDTH TEST

6.1 Measurement Procedure

Using the following spectrum analyzer settings:

1. Span= approximately 2 to 3 times the 20dB bandwidth, centered on a hopping channel.
2. Set the RBW = 30 kHz.
3. Set the VBW = 100 kHz.
4. Sweep time = auto couple.
5. Detector function = peak.
6. Trace mode = max hold.
7. Allow trace to fully stabilize.

6.2 Test SET-UP



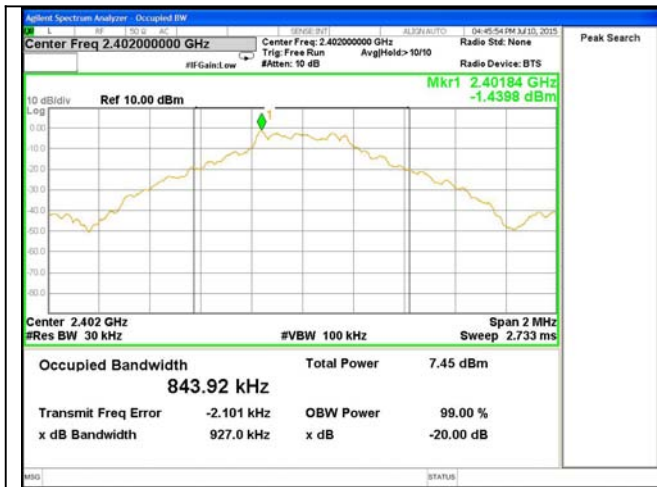
6.3 Test Equipment

Same as the equipment listed in 5.3.

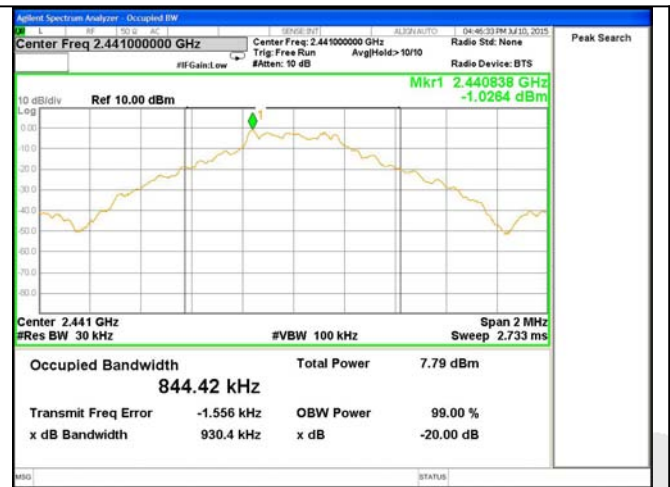
6.4 Test Results

Test Item	: 20dB BW	Test Mode	: CH Low ~ CH High
Test Voltage	: DC 3.7V	Temperature	: 24°C
Test Result	: PASS	Humidity	: 55%RH

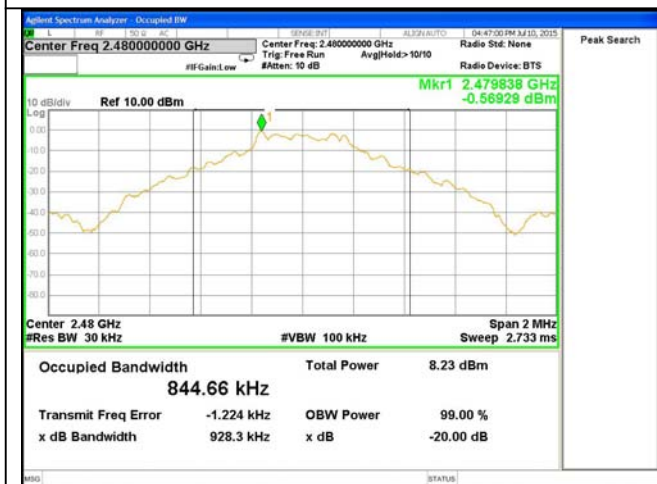
Channel	Frequency (MHz)	20dB Down BW(kHz)	Modulation Mode
Low	2401	927.0	BDR
Mid	2441	930.4	BDR
High	2480	928.3	BDR
Low	2401	1265.0	EDR
Mid	2441	1266.0	EDR
High	2480	1263.0	EDR



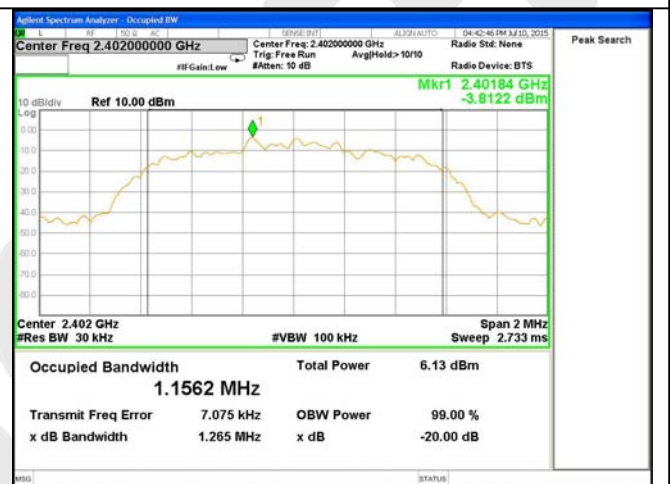
Test Mode: BDR---Low



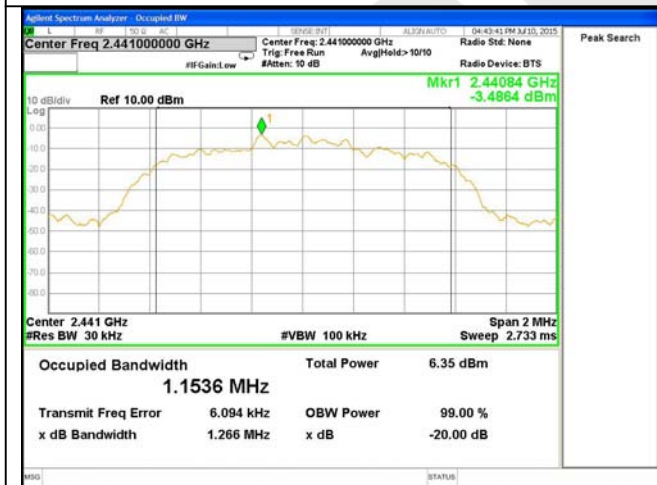
Test Mode: BDR---Mid



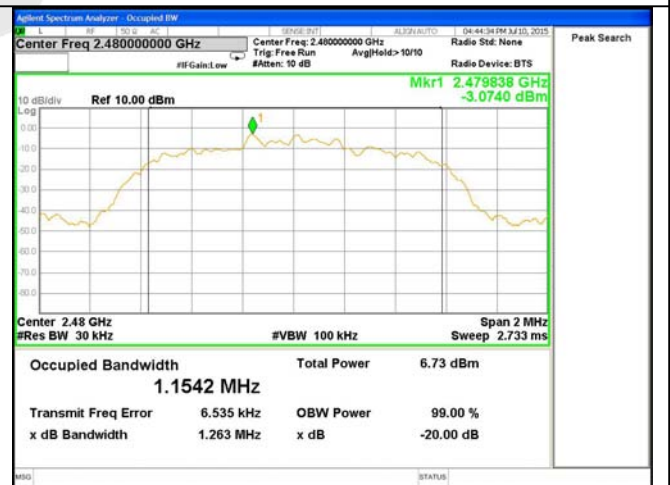
Test Mode: BDR---High



Test Mode: EDR---Low



Test Mode: EDR---Mid



Test Mode: EDR---High

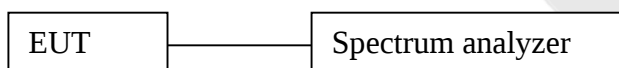
7. QUANTITY OF HOPPING CHANNEL TEST

7.1 Measurement Procedure

The EUT must have its hopping function enabled. Using the following spectrum analyzer setting:

1. Span= the frequency band of operation
2. Set the RBW = 1 MHz.
3. Set the VBW = 1 MHz.
4. Sweep time = auto couple.
5. Detector function = peak.
6. Trace mode = max hold.
7. Allow trace to fully stabilize.

7.2 Test SET-UP



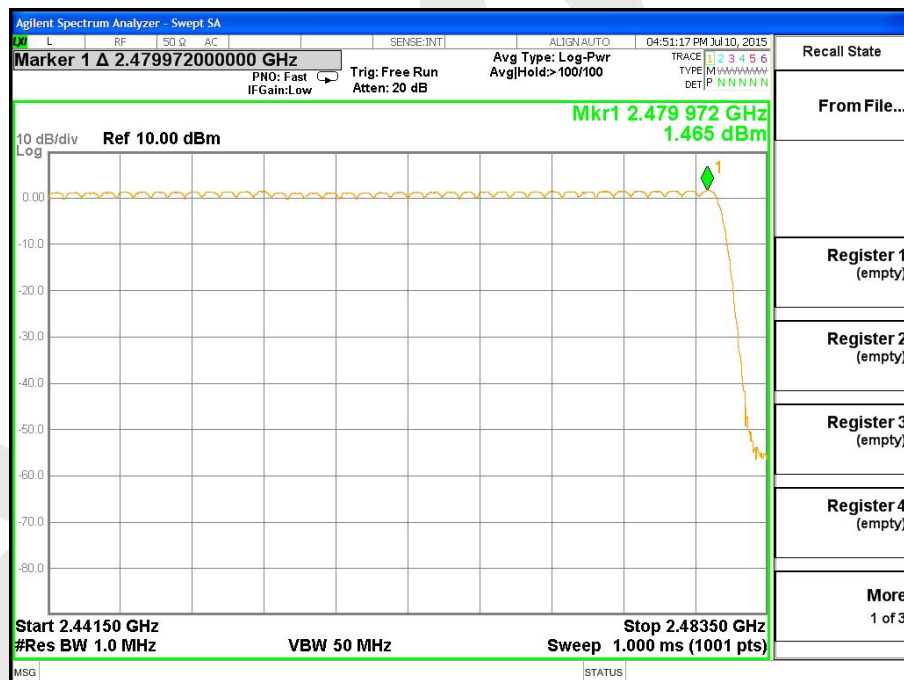
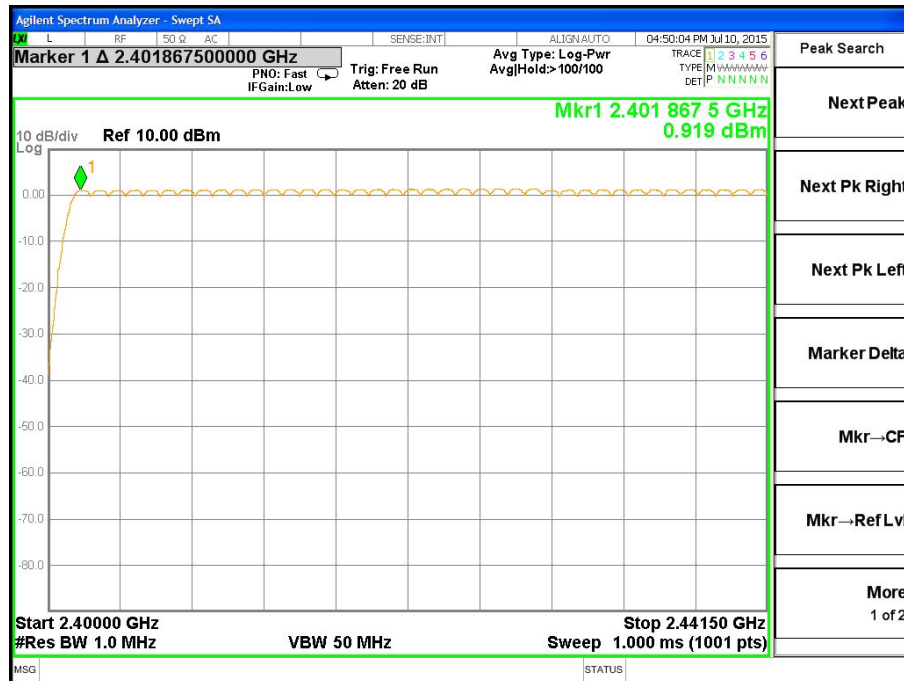
7.3 Test Equipment

Same as the equipment listed in 5.3.

7.4 Test Results

Test Item	: Number of Hopping Frequency	Test Mode	: CH Low ~ CH High
Test Voltage	: DC 3.7V	Temperature	: 24°C
Test Result	: PASS	Humidity	: 55%RH

Hopping Channel Frequency Range	Quantity of Hopping Channel	Quantity of Hopping Channel
2402-2480	79	> 15



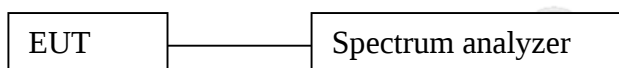
8. DWELL TIME TEST

8.1 Measurement Procedure

The EUT must have its hopping function enabled. Use the following spectrum analyzer settings:

1. Span= zero span, centered on a hopping channel
2. Set the RBW = 1 MHz.
3. Set the VBW = 1 MHz.
4. Sweep time = as necessary to capture the entire dwell time per hopping channel.
5. Detector function = peak.
6. Trace mode = max hold.
7. Allow trace to fully stabilize.

8.2 Test SET-UP



8.3 Test Equipment

Same as the equipment listed in 5.3.

8.4 Test Results

Test Item	: Time of Occupancy	Test Mode	: CH Low ~ CH High
Test Voltage	: DC 3.7V	Temperature	: 24°C
Test Result	: PASS	Humidity	: 55%RH

Package Type	Pulse width (ms)	Time slot length(ms)	Dwell time (ms)	Limit (s)
DH1	0.366	time slot length *1600/2 /79 * 31.6	117.12	0.4
DH3	1.625	time slot length *1600/4 /79 * 31.6	260.00	0.4
DH5	2.870	time slot length *1600/6 /79 * 31.6	306.13	0.4



DH1



DH3



DH5



/

9. MAXIMUM PEAK OUTPUT POWER TEST

9.1 Measurement Procedure

- Check the calibration of the measuring instrument(SA) using either an internal calibrator or a known signal from an external generator.
- Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range. Set a reference level on the measuring instrument equal to the highest peak value.
- The center frequency of the spectrum analyzer is set to the fundamental frequency and using proper RBW and VBW setting.
- Measure the captured power within the band and recording the plot.
- Repeat above procedures until all frequencies required were complete.

Using the following spectrum analyzer settings:

- Span= approximately 5 times the 20dB bandwidth, centered on a hopping channel
- Set the RBW = 3 MHz.
- Set the VBW = 3 MHz.
- Sweep time = auto couple.
- Detector function = peak.
- Trace mode = max hold.
- Allow trace to fully stabilize.

9.2 Test SET-UP



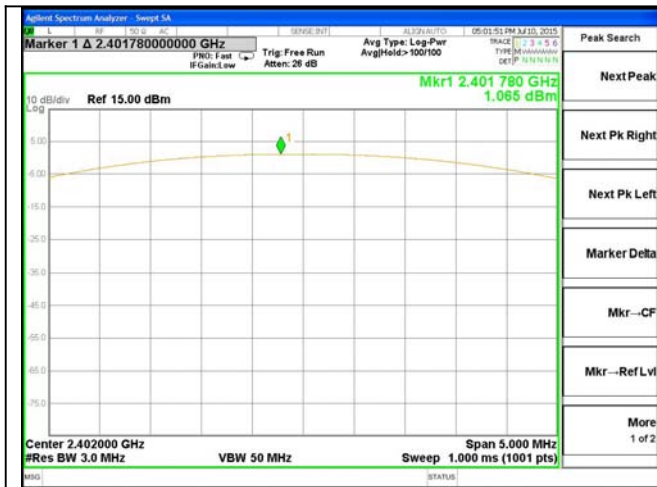
9.3 Test Equipment

Same as the equipment listed in 5.3.

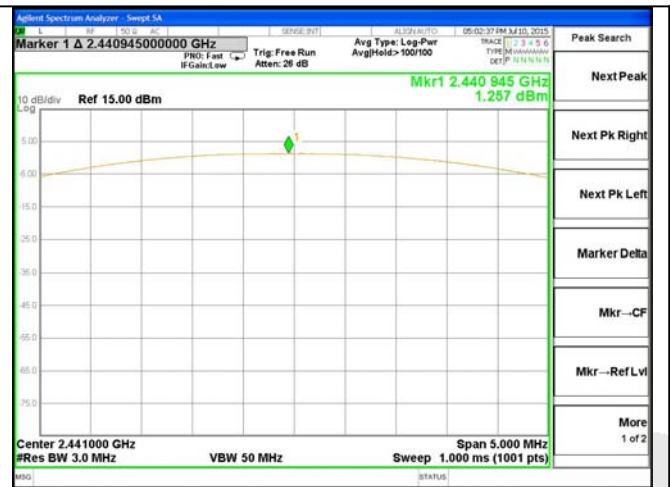
9.4 Test Results

Test Item : Max. peak output power Test Mode : CH Low ~ CH High
Test Voltage : DC 3.7V Temperature : 24℃
Test Result : PASS Humidity : 55%RH

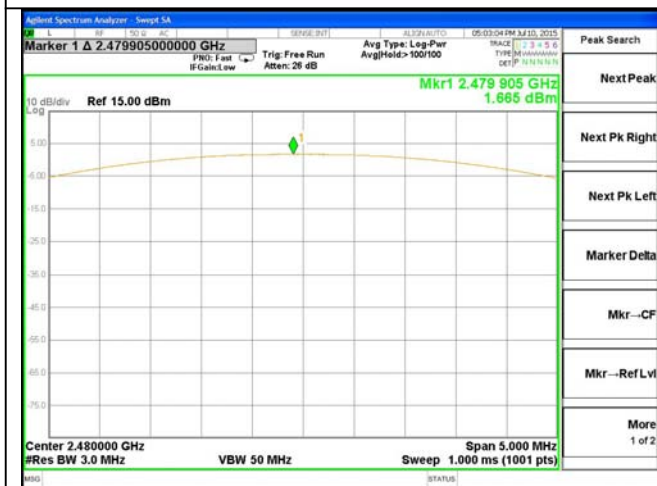
Channel Frequency (MHz)	Peak Power output(mW)	Peak Power output(dBm)	Peak Power Limit(mW)	Results	Modulation
2402	1.278	1.065	1000	PASS	BDR
2441	1.336	1.257	1000	PASS	BDR
2480	1.467	1.665	1000	PASS	BDR
2402	1.252	0.976	125	PASS	EDR
2441	1.317	1.197	125	PASS	EDR
2480	1.462	1.650	125	PASS	EDR



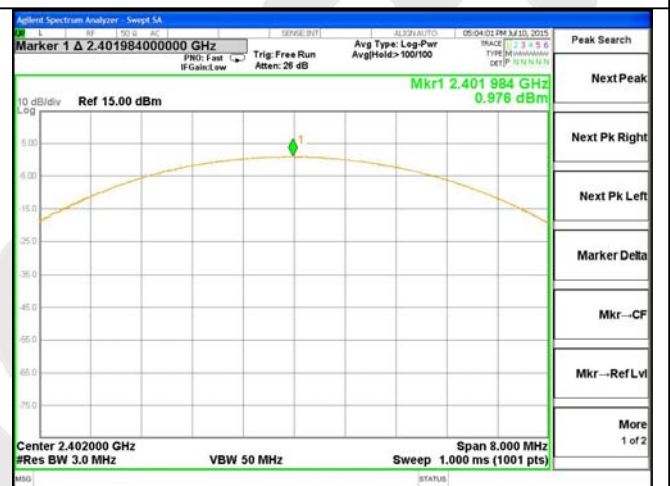
Test Mode: BDR---Low



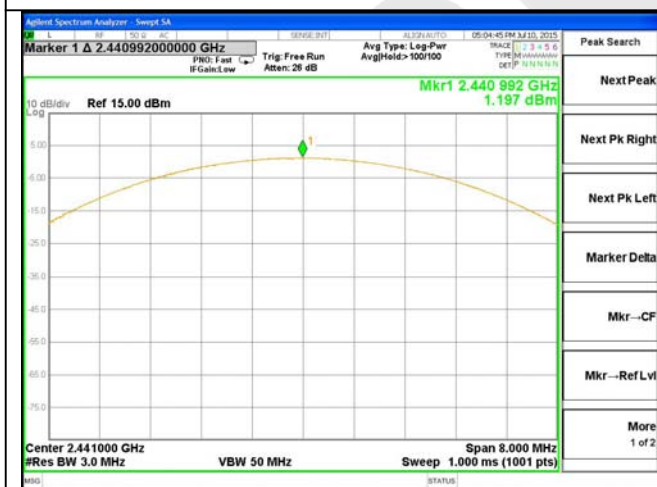
Test Mode: BDR---Mid



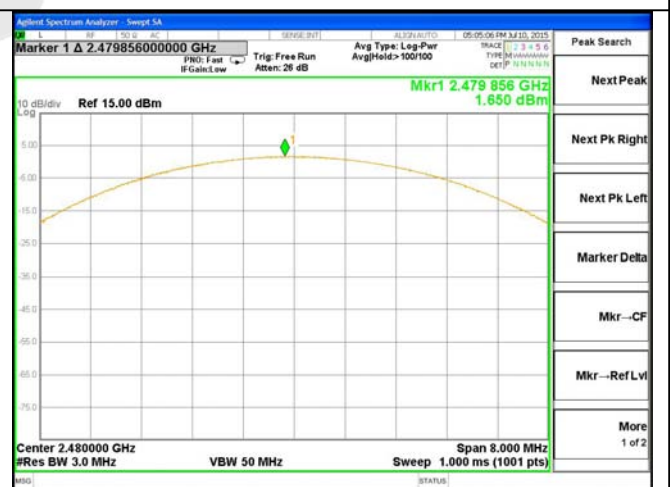
Test Mode: BDR---High



Test Mode: EDR---Low



Test Mode: EDR---Mid



Test Mode: EDR---High

10. BAND EDGE TEST

10.1 Measurement Procedure

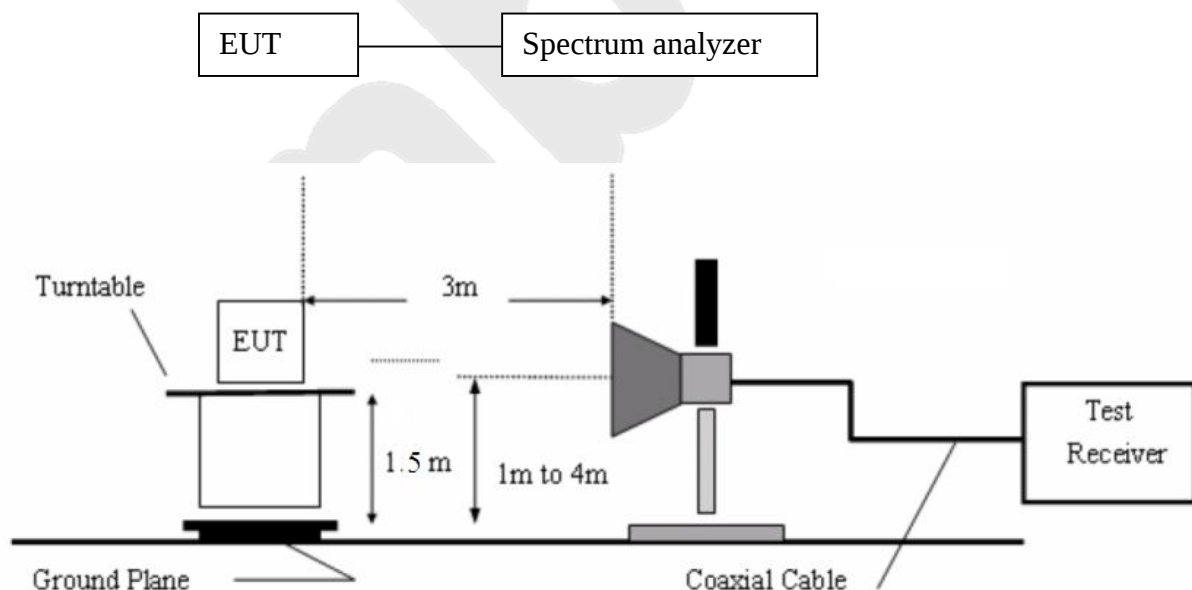
A) Conducted Emission method:

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT without connection to measurement instrument. Put it on the Rotated table and turn on the EUT and make it operate in transmitting mode. Then set it to low Channel and High Channel within its operating range, and make sure the instrument is operated in its linear range.
3. Set both RBW and VBW of spectrum analyzer to 100kHz with a convenient frequency span including 100kHz bandwidth from band edge,
4. Measurement the highest amplitude appearing on spectral display and set it as a reference level. Plot the graph with marking the highest point and edge frequency.
5. Report above procedures until all measured frequencies were complete.

B) Radiated Emission method:

The EUT is placed on a turn table which is 1.5 meter high above the ground. The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna which is mounted on a antenna tower. The antenna can be moved up and down from 1 to 4 meters to find out the maximum emission level. Rotated the EUT through three orthogonal axes to determine the maximum emissions, both horizontal and vertical polarization of the antenna are set on test. The EUT is tested in 9*6*6 Chamber. for Radiated emissions restricted band RBW= 1 MHz, VBW= 3 MHz.

10.2 Test SET-UP



10.3 Test Equipment

Same as the equipment listed in 5.3.

10.4 Test Results

Pass.

Please refer the following data.

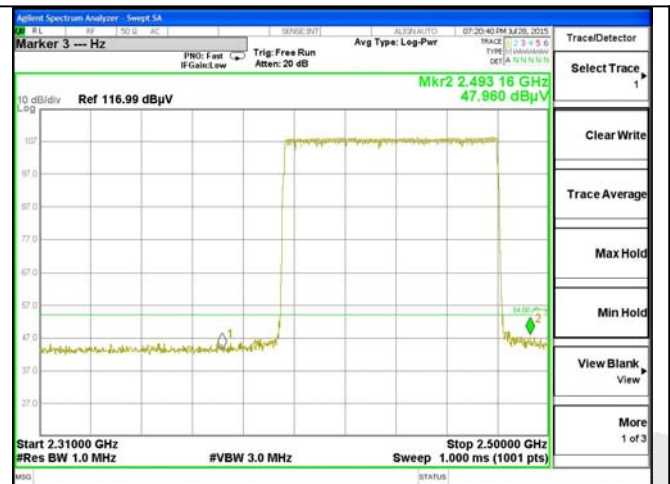
Test Item : Band eadge
Test Voltage : DC 3.7V
Test Result : PASS

Test Mode : CH Low ~ CH High
Temperature : 24℃
Humidity : 55%RH

For Hopping Mode:



Test Mode: BDR



Test Mode: BDR



Test Mode: EDR



Test Mode: EDR

Test Item : Band edge
Test Voltage : DC 3.7V
Test Result : PASS

Test Mode : CH Low ~ CH High
Temperature : 24℃
Humidity : 55%RH

For Non-Hopping Mode:**1. Conducted Test**

Frequency (MHz)	Peak Power Output(dBm)	Emission read Value(dBm)	Result of Band edge(dBc)	Band edge Limit(dBc)	Modulation
<2400	1.072	-36.867	37.939	>20dBc	BDR
	0.493	-29.080	29.573	>20dBc	EDR
>2483.5	1.183	-52.362	53.545	>20dBc	BDR
	0.830	-51.570	52.400	>20dBc	EDR

2. Radiated emission Test

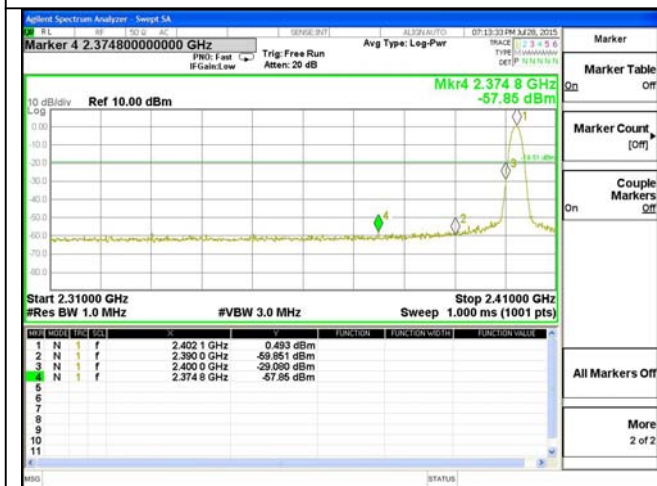
Frequency (MHz)	Antenna polarization (H/V)	Emission (dBuV/m)		Band edge Limit (dBuV/m)		Modulation
		PK	AV	PK	AV	
<2400	V	55.14	38.45	74.00	54.00	BDR
	V	52.48	36.74	74.00	54.00	EDR
>2483.5	V	54.93	37.21	74.00	54.00	BDR
	V	51.05	34.55	74.00	54.00	EDR



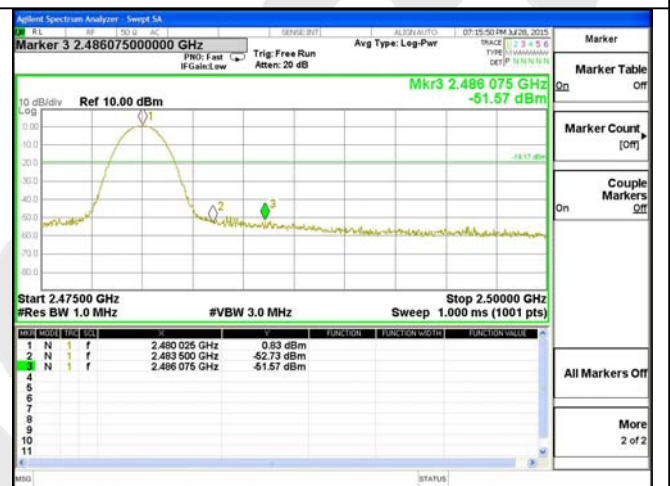
Test Mode: BDR



Test Mode: BDR



Test Mode: EDR



Test Mode: EDR

11. ANTENNA APPLICATION

11.1 Antenna requirement

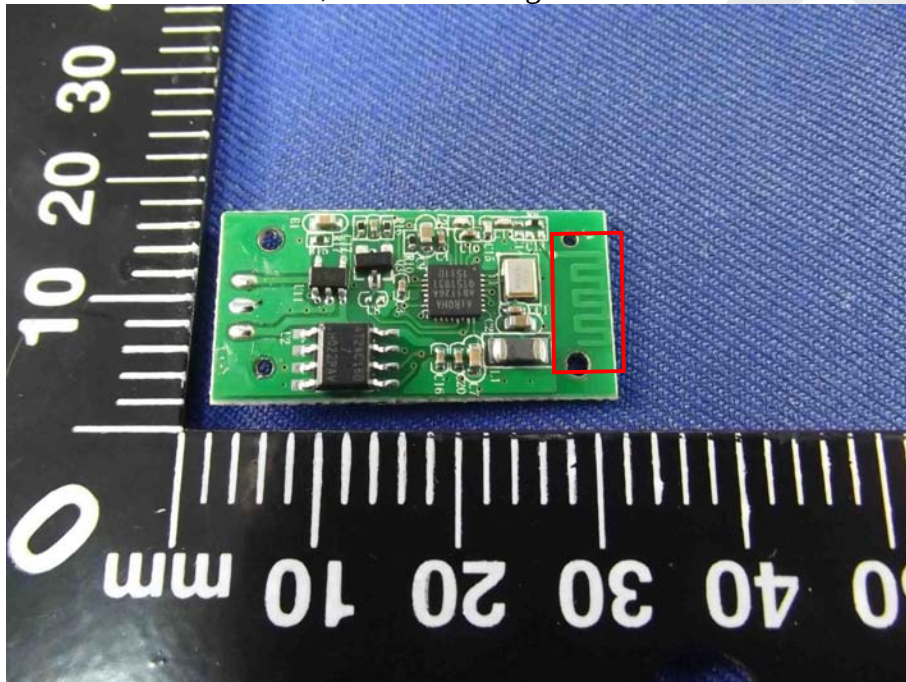
The EUT'S antenna is met the requirement of FCC part 15C section 15.203 and 15.247.

FCC part 15C section 15.247 requirements:

Systems operating in the 2402-2480MHz band that are used exclusively for fixed, point-to-point operations may employ transmitting antennas with directional gain greater than 6dBi provided the maximum peak output power of the intentional radiator is reduced by 1dB for every 3dB that the directional gain of the antenna exceeds 6dBi.

11.2 Result

The EUT's antenna used a PCB Antenna, The antenna's gain is -0.58dBi and meets the requirement.

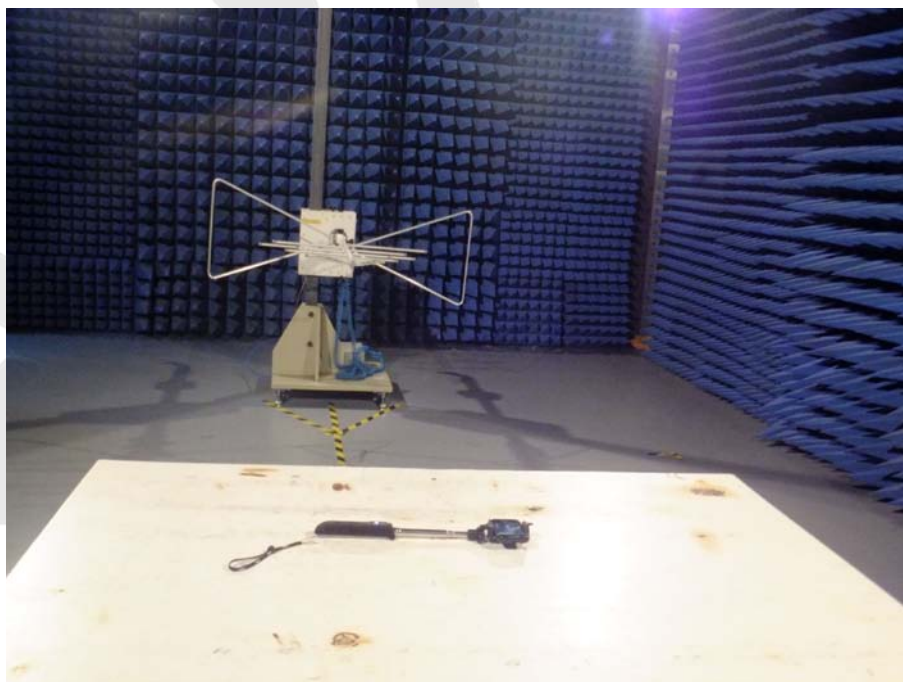


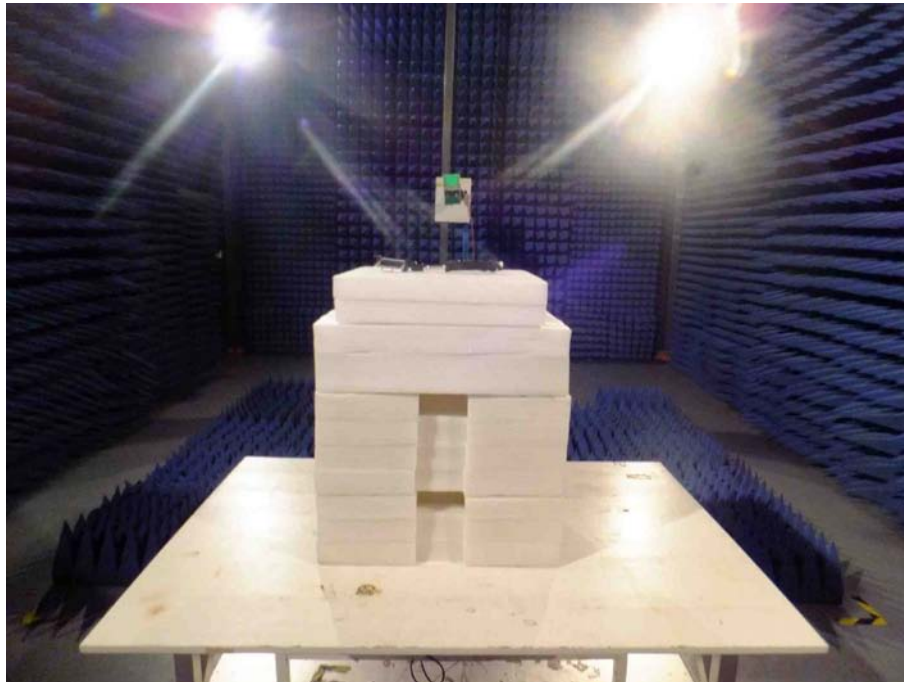
12. PHOTOGRAPH

12.1 Photo of Power Line Conducted Emission Measurement



12.2 Photo of Radiation Emission Test





APPENDIX I (EXTERNAL PHOTOS)

Figure 1
The EUT-Top View



Figure 2
The EUT-Bottom View

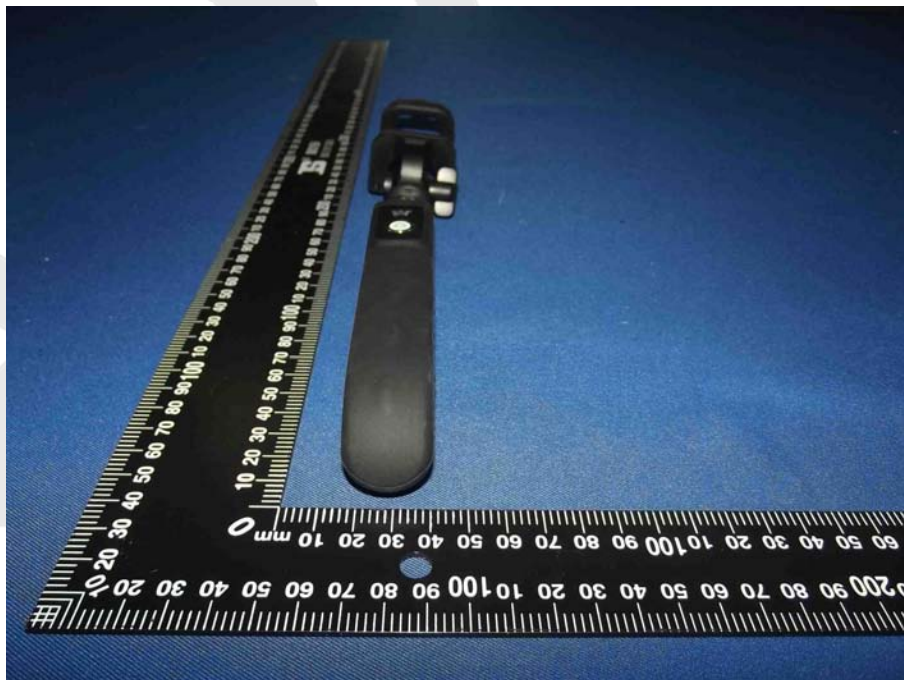


Figure 3
The EUT-Front View



Figure 4
The EUT-Back View



Figure 5
The EUT-Right View

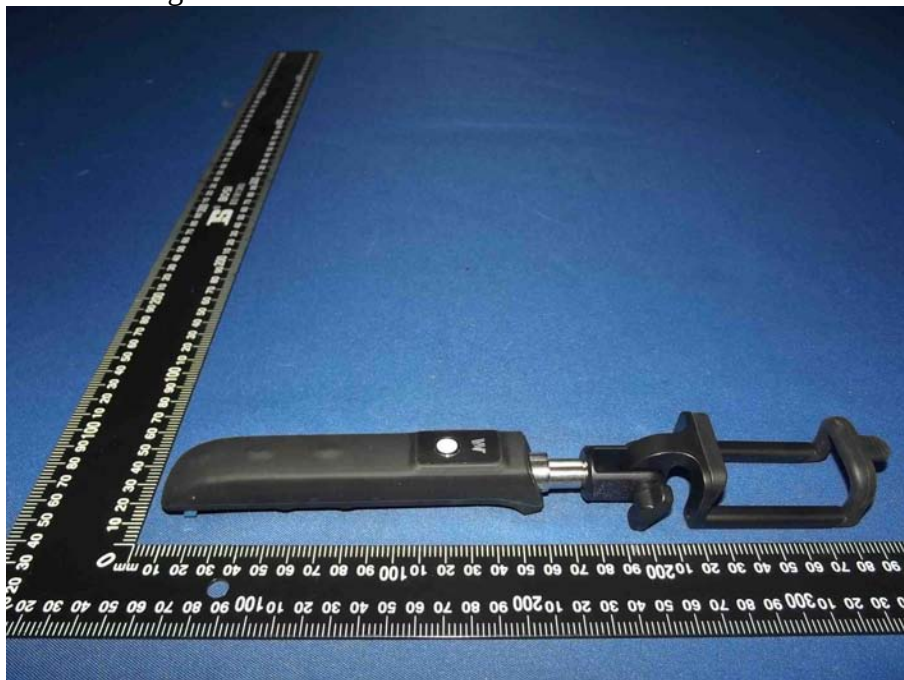


Figure 6
The EUT-Left View



APPENDIX II (INTERNAL PHOTOS)

Figure 7
The EUT-Inside View



Figure 8
The EUT-Inside View



Figure 9
The EUT-Inside View



Figure 10
PCB of the EUT-Front View

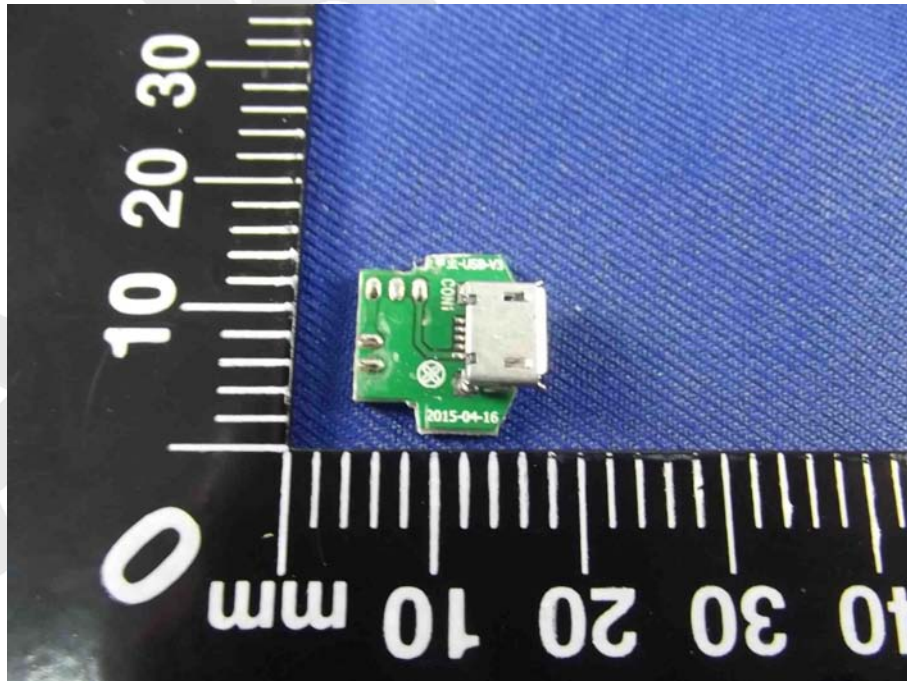


Figure 11
PCB of the EUT-Back View

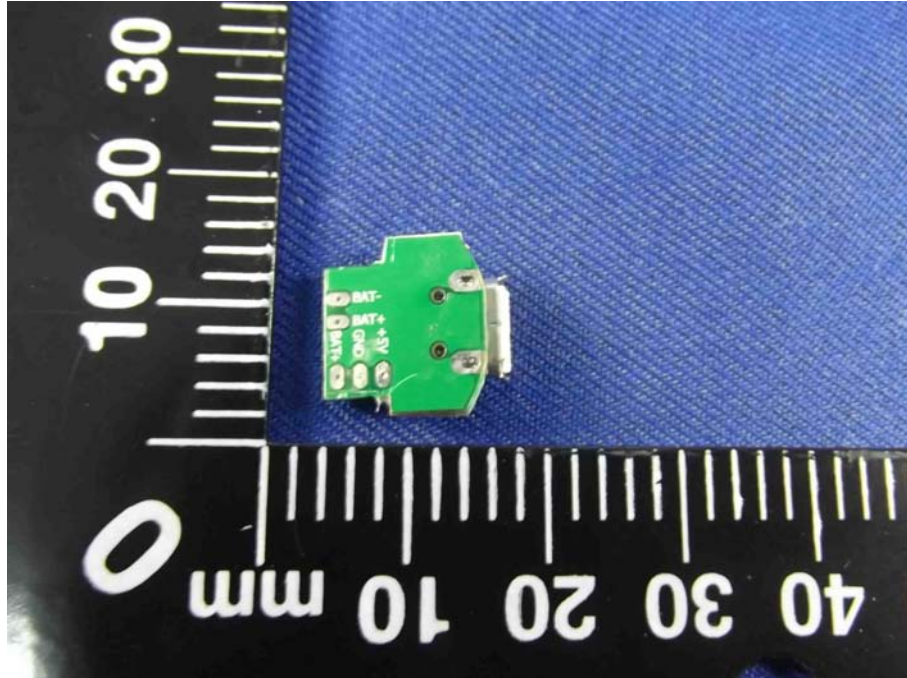


Figure 12
PCB of the EUT-Front View

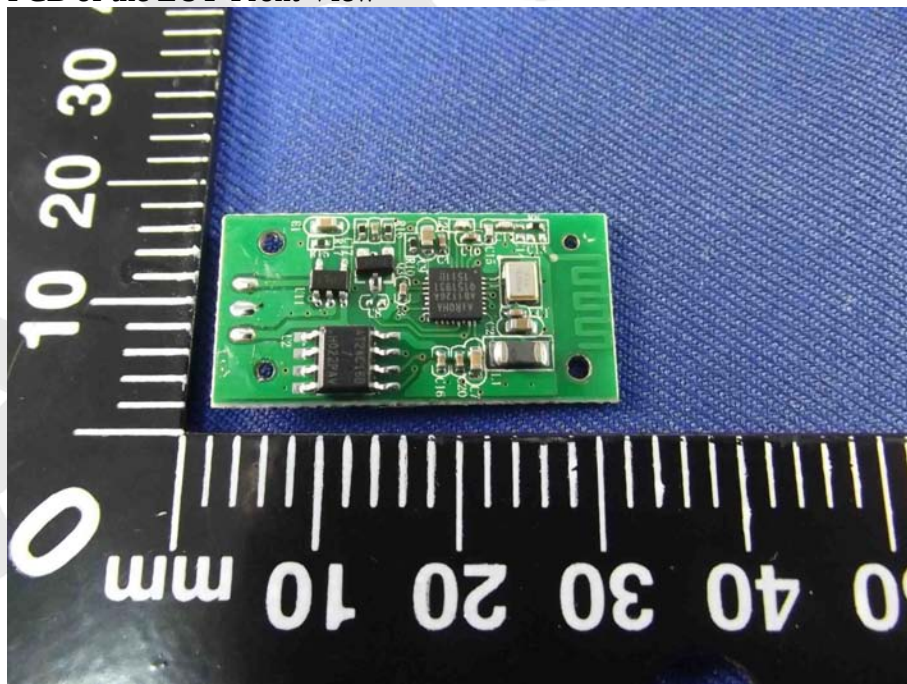


Figure 13
PCB of the EUT-Back View

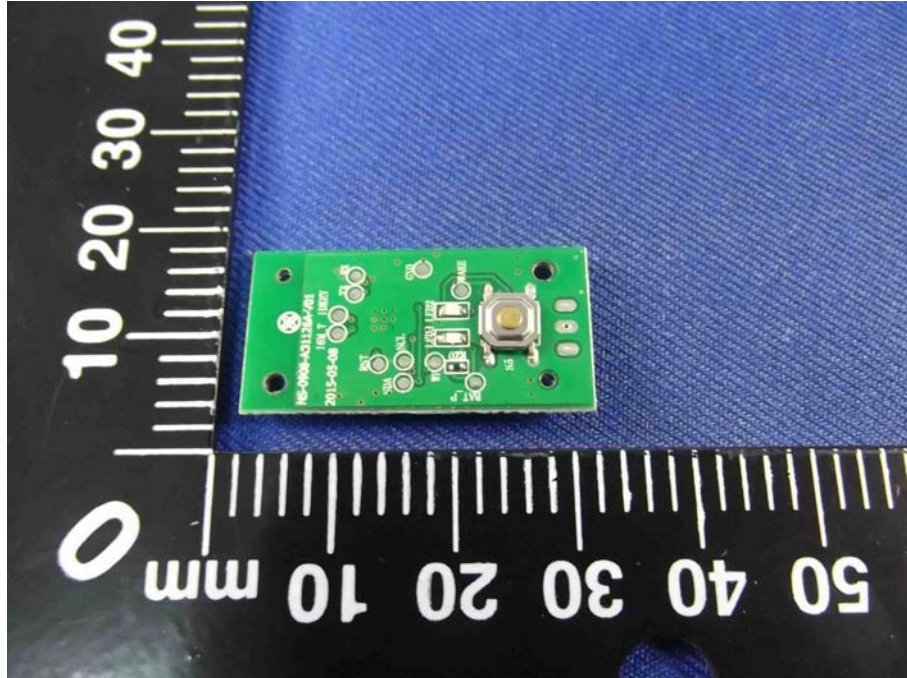


Figure 14
PCB of the EUT-Front View



Figure 15
PCB of the EUT-Back View

